# FCC TAS validation – Part 2: Tests under dynamic transmit power scenarios

FCC ID : A4RG8V0U

Equipment : Phone

Model Name : G8V0U, GF5KQ

Applicant : Google LLC

1600 Amphitheatre Parkway,

Mountain View, California, 94043 USA

**Standard** : FCC 47 CFR Part 2 (2.1093)

We, SPORTON INTERNATIONAL INC., would like to declare that the tested sample provide by manufacturer and the test data has been evaluated in accordance with the test procedures given in 47 CFR Part 2.1093 and FCC KDB and has been pass the FCC requirement.

The test results in this report apply exclusively to the tested model / sample. Without written approval of SPORTON INTERNATIONAL INC. EMC & Wireless Communications Laboratory, the test report shall not be reproduced except in full.

Approved by: Cona Huang / Deputy Manager

Cona Guang



Report No.: FA121931-04F

**Sporton International Inc. EMC & Wireless Communications Laboratory**No.52, Huaya 1st Rd., Guishan Dist., Taoyuan City 333, Taiwan

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**Appendix A. Test Setup Photos** 

# History of this test report

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## 1. Introduction

This purpose of this Part 2 report is to demonstrate that the DUT complies with FCC RF exposure compliance requirement under varying Tx power transmission scenarios, thus validating the Samsung S.LSI TAS algorithm feature for FCC equipment authorization of the handset.

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The values of Plimit used in this report per scenario are determined in Part 0 report.

# 2. Tx Varying Transmission Test Cases and Test Proposal

The following scenarios are covered in this report to demonstrate compliance with FCC RF exposure in Tx varying transmission conditions.

- 1. During a time-varying Tx power transmission to prove that TAS feature accounts for Tx power variations in time accurately.
- 2. During a call disconnect and re-establish scenario to prove that the TAS feature accounts for history of Tx power from past accurately
- 3. During a technology/band handover to prove that TAS feature accounts for history across transitions in band/technology
- 4. During operating state change to prove that TAS feature functions correctly to meet compliance limits across operate state changes
- 5. During time averaging window change to prove that TAS feature properly handles the change from one time averaging window to another as specified by FCC, and meets the normalized FCC limit of 1.0 at all time

As described in Part 0, the RF exposure is proportional to the Tx power for both FR1 and FR2. Thus, we rely on conducted power measurements (FR1) and radiated power measurements (FR2) in each dynamic case to demonstrate that overall RF exposure is within the FCC limit.

The overall procedure for validating the test is summarized below:

- 1. Measure conducted power (FR1) over time , denoted as TxPower(t), and radiated power EIRP (FR2) over time, denoted EIRP(t) , with time index t
- 2. Convert measured powers to RF exposure values using linear relationship shown below. In below expression, Pimit,sub-6 would be the measured power at which FR1 technology meets measured SAR level of SAR\_design\_target as described in Part 0. Similarly, Plimit,2 would be the measured EIRP at which FR2 technology meets measured PD level of PD\_design\_target as described in Part 0.

$$SAR(t) = \frac{TxPower(t)}{Plimit,sub-6} * SAR\_design\_target$$
 (2.1.1)

$$PD(t) = \frac{EIRP(t)}{Plimit,FR2} * PD\_design\_target$$
 (2.1.2)

3. Compute the average RF exposure over the most recent measurement duration which are denoted as  $T_{SAR}$  and  $T_{PD}$  for FR1 and FR2, respectively. These durations are as specified by FCC. This measurement duration interval is then given by [t - TSAR, t] and [t - TPD, t] for FR1 and FR2 respectively

TEL: 886-3-327-3456 Page: 5 of 82 FAX: 886-3-328-4978 Issued Date: Aug. 12, 2021 4. Divide the RF exposure for FR1 and FR2 by corresponding FCC limits and ensure the sum denoted as TER (total exposure ratio) is less than 1 for all. The following equation describes the calculation of TER and its target constraint, LSAR is the number of fixed, mobile or portable RF sources using SAR-based formula and LPD is the number of fixed, mobile or portable RF sources using PD (MPE)-based formula.

For sub-6 transmissions only:

$$\sum_{ISAR=0}^{LSAR-1} \frac{SARavr, ISAR}{FCC SAR} \le 1$$
 (2.1.3)

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For sub-6 and mmWave transmission:

$$\sum_{lSAR=0}^{LSAR-1} \frac{SARavr, lSAR}{FCC \ SAR} + \sum_{lPD=0}^{LPD-1} \frac{PDavr, lPD}{FCC \ PDlimit} \le 1$$
 (2.1.4)

Please note that EIRP in this document is the EIRP of bore-sight direction when bore-sight beam is used. Because EIRP can vary according to beam code setting in mmWave, a certain representative metric is required. Therefore, EIRP using bore-sight code at bore-sight direction is defined as Tx EIRP in this report. And the same amount of antenna input power setting is used for other beams as well as bore-sight beam.

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# 3. SAR Time Averaging Validation Test Procedures

Test plan and test procedure for validating Samsung SLSI TAS feature for sub-6 scenarios

## 3.1 Test sequence determination for validation

Two sequences for time varying Tx power are pre-defined as given below for sub-6 case.

Test Sequence A is generated with two power levels. One is maximum power level Pmax and the other is lower
power level. The lower power level is defined as 3dB lower value than maximum power level. At first, maximum
power level is applied for 120 seconds. After this, lower power level is used until this test is finished.

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Test Sequence B is generated at multiple power levels that are specified in the Appendix as a function of Pmax and Plimit.

#### 3.2 Test configuration selection criteria for validating TAS

This section provides general guidance for selecting test cases in TAS feature validation.

#### 3.2.1 Test configuration selection for time-varying Tx power transmission

The Samsung S.LSI TAS algorithm is independent of band, modes or channel of any technology. Hence, we can validate using one or two combinations of band/mode/channel per technology. The criteria for selecting these would be based on the relative value of Plimit and Pmax as determined in Part 0. Essentially, we need to pick this combination such that Plimit is less than Pmax so that the TAS algorithm will enforce power restriction. Two bands can be selected from Part 0 with different values of Plimit -select one corresponding to lowest Plimit and another being highest but still less than Pmax.

## 3.2.2 <u>Test configuration selection for change in call</u>

The criteria to select the technology/band for transition between call setup and call drop is to choose the one with least Plimit among all bands in Part 0. The test is performed with DUT requested power at Pmax so that the Samsung S.LSI TAS feature enforces power restriction for longest duration. The call change is performed when the DUT is operating with restricted power. One such test is sufficient since behavior is not dependent on band/technology.

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## 3.2.3 <u>Test configuration for change in technology/band/window</u>

FCC specifies different measurement durations for time averaging based on operating frequency. The change of operating frequency can result in change of time window for averaging, for e.g. change from 100s averaging for frequency below 3GHz to 60s averaging for frequency above 3-6 GHz. The criteria for selecting test case to demonstrate compliance across time window change is to pick a technology/band corresponding to each time window from Part 0 such that Plimit is less than Pmax.

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## 3.3 Test procedures for conducted power measurements

This section provides general conducted power measurement procedures to perform compliance test under dynamic scenarios described in Section 2.

#### 3.3.1 <u>Time-varying Tx power transmission scenario</u>

This test is performed with two pre-defined test sequences as described in Section 3.1 for all technologies operating on sub-6GHz applying to both LTE and NR as selected in Section 3.2.1. The purpose of the test is to demonstrate the maximum power limiting enforcement and that the time-averaged SAR does not exceed the FCC limit at all times.

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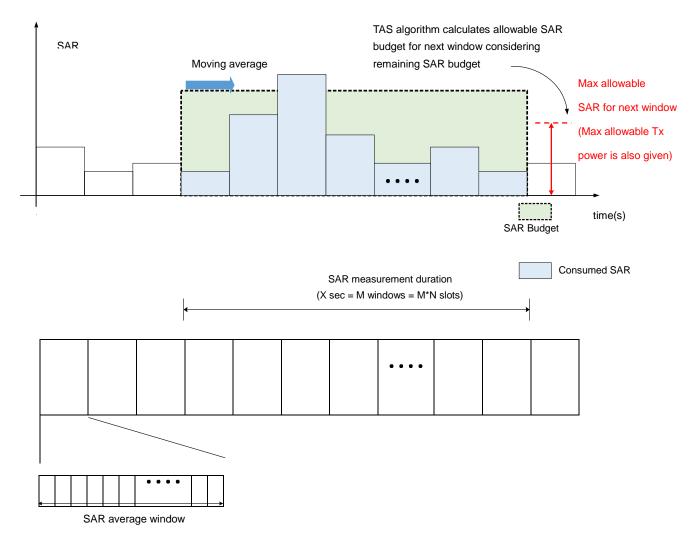


3.3.1.1 Test procedure

 Using the Pmax and Plimit obtained in Part 0/1, generate the test sequence of power levels for each selected technology/band. Both test sequences A and B are generated. Maximum power can be changed according to DUT test results

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2. Establish the connection of the DUT to the call box in the selected RAT, with the call box requesting the DUT Tx power to be according to the sequence determined in Step 1. An initial value of Tx power will be set to 0dBm for 100s before the desired test sequence starts to help with post-processing of the time-average value with the very first value in the sequence. This is illustrated in the figure below



Average SAR value in a slot can be calculated from average Tx power in the slot (Assume that SAR vs Tx power relation is obtained from real measurement)

Figure 3.3-1 SAR measurement from Tx power using block-wise processing

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- 3. Release connection.
- 4. After the completion of the test, prepare one plot with the following information:
  - a. Instantaneous Tx power versus time measured in Step 2
  - b. Requested Tx power versus time used in Step 2
  - c. Time-averaged power over 100s using instantaneous values from Step 2
  - d. Power level Plimit which is determined as meeting SAR target in Part 0/1
- 5. Make a second plot containing the following information:
  - a. Computed time-averaged 1gSAR versus time determined in Step 2
  - b. FCC 1gSAR limit of 1.6W/kg

The pass condition is to demonstrate time-averaged 1gSAR versus time shown in Step 5 value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration. We would also demonstrate that time-averaged power does not exceed the Plimit at any time in the plot in Step 4.

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#### 3.3.2 Change in call scenario

This test is to demonstrate that Samsung S.LSI TAS feature correctly accounts for past Tx powers during time- averaging when a new call is established. The call change has to be carried out when the power limit enforcement is ongoing.

#### 3.3.2.1 <u>Test procedure</u>

- 1. Establish radio connection of DUT with call box e.g. using LTE technology
- 2. Configure call box to set DUT Tx power to a low value of -10dBm for 100s.
- 3. Configure call box to send "ALL UP" power control commands and continue LTE transmission from DUT so that maximum power of Pmax is achieved.
- 4. After 60s of transmission at Pmax power level, release the call from call box.
- 5. After 10s, re-establish the LTE connection from call box to DUT and repeat sending "ALL UP" power control command to bring the Tx power to Pmax level again.
- 6. Continue LTE transmission at Pmax level for another 110s.
- 7. Release LTE connection.
- 8. After the completion of the test, prepare one plot with the following information (a) Instantaneous Tx power versus time (b) Requested Tx power versus time (c) Time-averaged power over 100s using instantaneous values and (d) Power level Plimit which is determined as meeting SAR target
- Make a second plot containing the following information (a) Computed time-averaged 1gSAR versus time and
   (b) FCC 1gSAR limit of 1.6W/kg

Pass condition is to demonstrate time-averaged 1gSAR value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration. It is required to check if SAR calculation is accounting for call drop and connection. Current TAS algorithm software makes the UE estimate the exact amount of Tx power and average SAR even during call drop and call re-establishment event. The UE stores time information when it goes into a sleep mode and wake-up to calculate Tx power on / off duration.

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#### 3.3.3 Change in technology/band/window

This test is to demonstrate that Samsung S.SLSI TAS feature can properly handle change of technology/band and consequently time window as necessary during handover scenarios. Since both Plimit and window duration can change across bands, we have to use separate equations below for converting Tx power to SAR as well as apply a combined SAR exposure criterion as shown below.

SAR 1 (t) = 
$$\frac{\text{TxPower(t)}}{\text{Plimit,sub6}} * SAR\_design\_target$$
 (3.3.1)

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SAR 2 (t) = 
$$\frac{\text{TxPower(t)}}{\text{Plimit,sub6}} * SAR\_design\_target$$
 (3.3.2)

where Plimit, 1, FR1 would correspond to measured power at which first technology/band meets measured SAR level of  $SAR\_design\_target1$  as described in Part 0 and Part 1 wit time-averaging duration of T1, SAR. Similarly, Plimit, FR2 would be the measured EIRP at which FR2 technology meets measured PD level of PD  $\_design\_target$  as described in Part 0. Similarly, the quantities  $Plimit, 2, FR1, SAR\_design\_target2, T2, SAR$  are defined for the second technology/band. When first band is chosen below 3GHz, we would have T1, = 100s, and by choosing second ban to be above 3GHz we would use T2, = 60s. On the other hand, when first band is chosen above 3GHz and second band below 3GHz, we would use T1, SAR = 60s and T1, SAR = 100s.

#### 3.3.3.1 Test procedure for switching from 100s to 60s and vice-versa

- Establish radio connection of DUT with call box e.g. using LTE technology in band A (e.g B2) which has 100s averaging duration.
- 2. Configure call box to set DUT Tx power to a low value of -10dBm for 100s.
- Configure call box to send "ALL UP" power control commands and continue LTE transmission from DUT so that
  maximum power of Pmax is achieved. Continue transmission at the maximum power for at least 105s.
- 4. Change band from band A (e.g. B2) to another LTE band B (e.g. B48), which should correspond to a change in averaging duration from 100s to 60s. Continue call in band B with call box requesting maximum power for at least 60s
- 5. Change band from band B(e.g.B48) back to the first band A(e.g.B2) and continue call at maximum power for at

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least 100s.

6. Release LTE connection

7. After the completion of the test, prepare one plot with the following information for each band (a) Instantaneous

Tx power versus time (b) Time-averaged power for each band according to their averaging duration and (c)

Plimit corresponding to each band

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8. Make a second plot containing the following information (a) Computed time-averaged 1gSAR versus time for each band (b) Sum of time-averaged SAR computed according to Eqn (3.3.1) and (3.3.2), and (c) FCC 1gSAR limit of 1.6W/kg

Pass condition is to demonstrate total time-averaged 1gSAR value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration. It is required to check if power limiting enforcement is operated as expected when band change occurs in-between.

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#### 3.3.3.2 Test procedure for switching from 60s to 100s and vice-versa

1. Establish radio connection of DUT with call box e.g. using LTE technology in band B (e.g.B48) which has 60s averaging duration.

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- 2. Configure call box to set DUT Tx power to a low value of -10dBm for 100s.
- 3. Configure call box to send "ALL UP" power control commands and continue LTE transmission from DUT so that maximum power of Pmax is achieved. Continue transmission at the maximum power for at least 65s.
- 4. Change band from band B (e.g.B48) to another LTE band A (e.g.B2), which should correspond to a change in averaging duration from 60s to 100s. Continue call in band A with call box requesting maximum power for at least 100s
- 5. Change band from band A(e.g.B2) back to the first band B(e.g.B48) and continue call at maximum power for at least 60s.
- 6. Release LTE connection
- 7. After the completion of the test, prepare one plot with the following information for each band (a) Instantaneous

  Tx power versus time (b) Time-averaged power for each band according to their averaging duration and (c)

  Plimit corresponding to each band
- 8. Make a second plot containing the following information (a) Computed time-averaged 1gSAR versus time for each band (b) Sum of time-averaged SAR computed according to Eqn (3.3.1) and (3.3.2), and (c) FCC 1gSAR limit of 1.6W/kg

Pass condition is to demonstrate total time-averaged 1gSAR value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration. It is required to check if power limiting enforcement is operated as expected when band change occurs in-between.

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# 4. PD Time Averaging Validation Test Procedures

In this section, we cover the test plan and test procedure for validating Samsung SLSI TAS feature for FR2 scenarios. For this DUT, FR2 transmissions are only in non-standalone mode, so it requires LTE as an anchor, and both SAR for LTE and PD for FR2 will be accounted.

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## 4.1 Test sequence determination for validation

In FR2 transmissions, the test sequence for validation is with the callbox requested maximum power for FR2 at all time.

# 4.2 Test configuration selection criteria for validating TAS

#### 4.2.1 Test configuration selection for time-varying Tx power transmission

Since the TAS feature is independent of band and beams for a given technology, demonstration with one band will be sufficient.

#### 4.2.2 <u>Test configuration selection for time-varying Tx power transmission</u>

The TAS feature works for both types of exposure (SAR or PD) and ensures total time-averaged exposure ratio meets the FCC limit of 1. One scenarios of LTE band and FR2 band is sufficient, while exposure condition can be varied between SAR dominant, SAR+PD scenario and PD dominant scenarios for demonstration.

#### 4.2.3 <u>Test configuration selection for change of beam</u>

Since the TAS feature is independent of band and beams for a given technology, demonstration with one pair of beams for switching between them will be sufficient.

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#### 4.3 Test procedures for FR2 radiated power measurements

For FR2 testing, we need to perform conducted power measurements for LTE and radiated power measurements for FR2. This section provides general procedures for test setup to validate the compliance in dynamic scenarios outlines in Section 2.

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#### 4.3.1 FR2 max power transmission

#### 4.3.1.1 Test procedure

- Set the phone in an anechoic chamber for FR2 radiated transmission. In a non-signaling transmission mode for FR2 at maximum target EIRP, adjust the position of the DUT via rotation within the chamber to obtain the maximum measured radiated EIRP using the fixed test antenna. Keep the DUT in this fixed position for the remainder of the test.
- 2. Reset the DUT state to normal signaling mode and establish both LTE and FR2 connections with the call box.
- 3. Immediately send "ALL DOWN" power control commands from LTE call box to send LTE to the lowest transmission power. Next, configure the FR2 call box to send "ALL UP" power control commands to send FR2 radio to maximum EIRP condition. In this case, the FR2 radio will comprise the dominant exposure condition using PD metric.
- 4. After 120s, configure LTE call box to send "ALL UP" power control commands and continue transmission.
- 5. Record the conducted power of LTE and radiated EIRP of FR2 radio at all times during the test.
- 6. After 200s, release LTE and FR2 connection.
- 7. After the end of the test, convert the instantaneous LTE Tx power into 1gSAR value using Plimit and Eqn (2.1.1), and then divide by FCC limit of 1.6W/Kg to obtain normalized SAR versus time. Perform 100s time averaging to determine normalized average 1gSAR versus time.
- 8. Similar to Step 7, convert the instantaneous radiated FR2 EIRP into PD value using Plimit and Eqn (2.1.2), and then divide by FCC limit of 10W/m<sup>2</sup> for 4cm<sup>2</sup> spatial averaging to obtain instantaneous normalized PD versus time. Perform 4s time averaging to determine normalized average PD versus time.
- Make one plot containing (a) Instantaneous conducted power for LTE, (b) computed 100s time-averaged power for LTE, (c) Instantaneous EIRP for FR2, (d) computed 4s time averaged EIRP for FR2 and (e) Plimit for each of LTE and FR2
- 10. Make a second plot containing (a) normalized 100s time-averaged SAR for LTE computed in Step 7 (b)

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normalized 4s time-averaged PD for FR2, (c) TER (Total Exposure Ratio) corresponding total normalized time-averaged RF exposure (using sum of 10(a) and 10(b)) versus time

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Pass condition is to demonstrate that TER is kept under 1.0 throughout the test. This ensures that criteria defined in is met at all times.

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#### 4.3.2 SAR vs PD exposure switch during transmission

This test is to ensure that Samsung S.LSI TAS feature works for any nature of exposure (SAR or PD) and accurately accounts for switching among SAR dominant, SAR+PD, and PD dominant scenarios, and ensured total time-averaged RF exposure compliance at all times.

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#### 4.3.2.1 <u>Test procedure</u>

- Set the DUT in an anechoic chamber for FR2 radiated transmission. In a non-signaling transmission mode for FR2 at maximum target EIRP, adjust the position of the DUT via rotation within the chamber to obtain the maximum measured radiated EIRP using the fixed test antenna. Keep the DUT in this fixed position for the remainder of the test.
- 2. Reset the DUT state to normal signaling mode and establish both LTE and FR2 connections with the call box.
- 3. Immediately send "ALL DOWN" power control commands from LTE call box to send LTE to the lowest transmission power. Next, configure the FR2 call box to send "ALL UP" power control commands to send FR2 radio to maximum EIRP condition. In this case, the FR2 radio will comprise the dominant exposure condition using PD metric.
- 4. After 120s, configure LTE call box to send "ALL UP" power control commands and continue transmission. Now, the RF exposure margin for FR2 should begin to reduce and could cause reduction in EIRP or stopping of FR2 transmissions.
- After 120s, configure LTE call box to send "ALL DOWN" power control commands and continue transmission.
   Now, the FR2 radio should begin to obtain more RF exposure margin and start its transmission at higher power again.
- 6. Record the conducted power of LTE and radiated EIRP of FR2 radio at all times during the test.
- 7. Release LTE and FR2 connection.
- 8. After the end of the test, convert the instantaneous LTE Tx power into 1gSAR value using Plimit and Eqn (2.1.1), and then divide by FCC limit of 1.6W/Kg to obtain normalized SAR versus time. Perform 100s time averaging to determine normalized average 1gSAR versus time.
- 9. Similar to Step 7, convert the instantaneous radiated FR2 EIRP into PD value using Plimit and Eqn (2.1.2), and then divide by FCC limit of 10W/m<sup>2</sup> for 4cm<sup>2</sup> spatial averaging to obtain instantaneous normalized PD versus time. Perform 4s time averaging to determine normalized average PD versus time.
- 10. Make one plot containing (a) Instantaneous conducted power for LTE, (b) computed 100s time- averaged power for LTE, (c) Instantaneous EIRP for FR2, (d) computed 4s time averaged EIRP for FR2 and (e) Plimit for

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each of LTE and FR2

11. Make a second plot containing (a) normalized 100s time-averaged SAR for LTE computed in Step 7 (b) normalized 4s time-averaged PD for FR2, (c) TER (Total Exposure Ratio) corresponding total normalized time-averaged RF exposure (using sum of 10(a) and 10(b)) versus time

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Pass condition is to demonstrate that TER is kept under 1.0 throughout the test. This ensures that criteria defined in is met at all times.

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#### 4.3.3 Change of beam

This test is to demonstrate that Samsung S.LSI TAS feature can account for change of beam in FR2 and still meet total RF exposure compliance.

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#### 4.3.3.1 Test procedure

- Set the DUT in an anechoic chamber for FR2 radiated transmission. In a non-signaling transmission mode for FR2 at beam of maximum target EIRP, adjust the position of the DUT via rotation within the chamber to obtain the maximum measured radiated EIRP using the fixed test antenna.
- 2. Reset the DUT state to normal signaling mode and establish both LTE and FR2 connections with the call box.
- 3. Immediately send "ALL DOWN" power control commands from LTE call box to send LTE to the lowest transmission power. Next, configure the FR2 call box to send "ALL UP" power control commands to send FR2 radio to maximum EIRP condition. In this case, the FR2 radio will comprise the dominant exposure condition using PD metric.
- 4. After 20s, the test equipment turns the DUT by 30 degrees (horizontal=30, vertical=0) to change best module and correspondingly a beam change.
- 5. After 20s, the test equipment turns the DUT by 60 degrees (horizontal=60, vertical=0) to change best module again and correspondingly a beam change.
- 6. Continue the LTE and FR2 transmissions for another 20s
- 7. Record the conducted power of LTE and radiated EIRP of FR2 radio and per beam at all times during the test.
- 8. Release LTE and FR2 connection.
- After the end of the test, convert the instantaneous LTE Tx power into 1gSAR value using Plimit and Eqn (2.1.1), and then divide by FCC limit of 1.6W/Kg to obtain normalized SAR versus time. Perform 100s time averaging to determine normalized average 1gSAR versus time.
- 10. Similar to Step 9, convert the instantaneous radiated FR2 EIRP into PD value using Plimit and Eqn (2.1.2), and then divide by FCC limit of 10W/m<sup>2</sup> for 4cm<sup>2</sup> spatial averaging to obtain instantaneous normalized PD versus time for each beam. Perform 4s time averaging to determine normalized average PD versus time. Note that for each beam, we have to use the corresponding Plimit values before converting to the PD values.
- 11. Make one plot containing (a) Instantaneous conducted power for LTE, (b) computed 100s time- averaged power for LTE, (c) Instantaneous EIRP for FR2 per beam, (d) computed 4s time averaged EIRP for FR2 per beam and (e) Plimit for each of LTE and FR2

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12. Make a second plot containing (a) normalized 100s time-averaged SAR for LTE computed in Step 7 (b) normalized 4s time-averaged PD for FR2 per beam, (c) TER (Total Exposure Ratio) corresponding total normalized time-averaged RF exposure (using sum of 12(a) and 12(b)) versus time as computed in left hand side of equation below

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Pass condition is to demonstrate time-averaged 1gSAR value and 4cm2 PD versus time does not exceed the FCC limits of 1.6 W/kg and 10W/m2 throughout the test duration. And TER (Total Exposure Ratio) as in Eqn should be kept under 1.0 throughout the test. It is required to check if power limiting enforcement is operated as expected during the test.

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# 5. <u>Test Configurations</u>

### 5.1 WWAN (sub-6) transmission

- 1. The Plimit values correspond to SAR\_design\_target.
- 2. GSM and WCDMA don't support time average feature of dynamic power varying, the power will be fixed at the static reduce power level at different exposure conditions for RF exposure compliance. For the GSM (TDD) Plimit power levels in the table correspond to the burst average power levels which don't account for TX duty cycle.

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Table 5.1.1: Plimit for supported technologies and bands (Plimit corresponding to SAR design target )

	_				-	_	_	_		
				Н	ead	Hotspot	Body-wor	n/Extremity		
Wireless				Standalone	Simultaneous	Simultaneous	Standalone	Simultaneous	Pmax Burst	
technology/ band (No Accounting	Config	Config	Antenna	duty cycle	Index 2	Index 3	Index 4	Index 5	Index 6	average
duty cycle)						power (dBm)				
					(ubiii)					
GSM850 GPRS 1TX	TX0	0	12.50%	42.50	41.30	42.40	43.60	42.40	33.00	
GSM850 GPRS 2TX	TX0	0	25.00%	39.50	38.30	39.40	40.60	39.40	31.50	
GSM850 GPRS 3TX	TX0	0	37.50%	38.00	36.80	37.60	38.80	37.60	30.50	
GSM850 GPRS 4TX	TX0	0	50.00%	36.50	35.30	36.40	37.60	36.40	29.50	
GSM1900 GPRS 1TX	TX0	2	12.50%	41.00	39.80	30.10	31.30	30.10	30.00	
GSM1900 GPRS 2TX	TX0	2	25.00%	38.00	36.80	27.10	28.30	27.10	28.50	
GSM1900 GPRS 3TX	TX0	2	37.50%	36.00	34.80	25.30	26.50	25.30	28.00	
GSM1900 GPRS 4TX	TX0	2	50.00%	35.00	33.80	24.10	25.30	25.30	27.00	
WCDMA B2	TX0	2	100.00%	31.20	30.00	22.40	23.60	23.60	24.30	
WCDMA B4	TX0	2	100.00%	31.70	30.50	22.00	23.20	22.80	24.30	
WCDMA B5	TX0	0	100.00%	31.00	29.80	28.30	29.50	28.30	24.40	

Table 5.1.2: Plimit for supported technologies and bands (Plimit corresponding to SAR design target )

				Н	ead	Hotspot	Body-wor	n/Extremity			
Wireless		Antenna		Standalone	Simultaneous	Simultaneous	Standalone	Simultaneous	P Max Burst		
technology/ band (No Accounting	Config		duty cycle	Index 2	Index 3	Index 4	Index 5	Index 6	average		
duty cycle)					P limit Burst average power (dBm)						
GSM850 GPRS 1TX	TX1	1	12.50%	35.00	33.80	37.80	39.00	37.80	33.00		
GSM850 GPRS 2TX	TX1	1	25.00%	32.00	30.80	34.80	36.00	34.80	31.00		
GSM850 GPRS 3TX	TX1	1	37.50%	30.00	28.80	32.80	34.00	32.80	29.70		
GSM850 GPRS 4TX	TX1	1	50.00%	29.00	27.80	31.80	33.00	31.80	28.50		
GSM1900 GPRS 1TX	TX1	0	12.50%	38.50	37.30	32.20	33.40	32.20	29.80		
GSM1900 GPRS 2TX	TX1	0	25.00%	35.50	34.30	29.20	30.40	29.20	27.70		
GSM1900 GPRS 3TX	TX1	0	37.50%	34.00	32.80	27.70	28.90	27.70	26.50		
GSM1900 GPRS 4TX	TX1	0	50.00%	32.50	31.30	26.20	27.40	26.20	25.20		
WCDMA B2	TX1	0	100.00%	28.10	26.90	22.10	23.30	22.10	23.30		
WCDMA B4	TX1	0	100.00%	30.20	29.00	25.10	26.30	25.10	23.50		
WCDMA B5	TX1	1	100.00%	24.50	23.30	28.10	29.30	28.10	24.20		

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Table 5.1.3: Plimit for supported technologies and bands (Plimit corresponding to SAR design target )

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				H	ead	Hotspot	Body-wor	n/Extremity	
Wireless				Standalone	Simultaneous	Simultaneous	Standalone	Simultaneous	P Max
technology/ band (Accounting duty	Config	Antenna	duty cycle	Index 2	Index 3	Index 4	Index 5	Index 6	Time-average
cycle)					power (dBm)				
					time-a	verage power (	(dBm)		
LTE B7	TX0	2	100.00%	30.7	29.5	20.1	21.3	20.1	24.5
LTE B12/17	TX0	0	100.00%	31.7	30.5	29.8	31	29.8	24.5
LTE B13	TX0	0	100.00%	31.4	30.2	28.9	30.1	28.9	24.5
LTE B14	TX0	0	100.00%	31.1	29.9	29	30.2	29	24.5
LTE B25/2	TX0	2	100.00%	31.2	30	21	22.2	22.2	24.5
LTE B26/5	TX0	0	100.00%	30.9	29.7	28.9	30.1	28.9	24.5
LTE B30	TX0	2	100.00%	33.9	32.7	20.8	22	20.8	24.5
LTE B41/38	TX0	2	63.30%	30	28.8	21.3	22.5	21.3	22.5
LTE B38 HPUE	TX0	2	43.30%	30	28.8	21.3	22.5	21.3	22.4
LTE B41 HPUE	TX0	2	43.30%	30	28.8	21.3	22.5	21.3	22.9
LTE B48	TX0	2	63.30%	28.6	27.4	21.3	23.4	22.2	22.5
LTE B66/4	TX0	2	100.00%	32.6	31.4	20.7	22.8	22.8	24.5
LTE B71	TX0	0	100.00%	31.6	30.4	29.1	30.3	29.1	24.5
FR1 n25/2	TX0	2	100.00%	30.5	29.3	20.9	22.1	22.1	24.5
FR1 n5	TX0	0	100.00%	30.6	29.4	28.5	29.7	28.5	24.5
FR1 n7	TX0	2	100.00%	30.4	29.2	20.4	21.6	20.4	24.5
FR1 n12	TX0	0	100.00%	31.7	30.5	30.1	31.3	30.1	24.5
FR1 n30	TX0	2	100.00%	31.6	30.4	21.2	22.4	21.2	24.5
FR1 n41/n38	TX0	1	100.00%	17.5	16.3	19.9	22.5	21.3	24.5
FR1 n41 HPUE	TX0	1	50.00%	17.5	16.3	19.9	22.5	21.3	23
FR1 n66	TX0	2	100.00%	32	30.8	21.2	22.4	22.4	24.5
FR1 n71	TX0	0	100.00%	32.5	31.3	29.4	30.6	29.4	24.5
FR1 n77	TX0	6	100.00%	27.9	26.7	21.1	22.3	22.3	24.3
FR1 n77 HPUE	TX0	6	50.00%	27.9	26.7	21.1	22.3	22.3	23

LTE and 5GNR TDD: Plimit power levels in the table correspond to the time-averaged power levels which accounts for TX duty cycle.

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<sup>2.</sup> Maximum target power, Pmax, is configured in NV settings in EUT to limit maximum transmitting power. This power is converted into peak power in NV settings for TDD scheme

Table 5.1.4: Plimit for supported technologies and bands (Plimit corresponding to SAR design target)

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				H	ead	Hotspot	Body-wor	n/Extremity	
Wireless				Standalone	Simultaneous	Simultaneous	Standalone	Simultaneous	P Max
technology/ band (Accounting duty	Config	Antenna	duty cycle	Index 2	Index 3	Index 4	Index 5	Index 6	Time-average
cycle)					power (dBm)				
					time-a	verage power (	(dBm)		
LTE B7	TX1	0	100.00%	28.1	26.9	21	22.2	22.2	23.1
LTE B12/17	TX1	1	100.00%	28.5	27.3	29.1	30.3	29.1	24.2
LTE B13	TX1	1	100.00%	28.7	27.5	28.9	30.1	28.9	24.2
LTE B14	TX1	1	100.00%	26.6	25.4	29.1	30.3	29.1	24.2
LTE B25/2	TX1	0	100.00%	28.5	27.3	22.6	23.8	22.6	23.6
LTE B26/5	TX1	1	100.00%	27.5	26.3	27.9	29.1	27.9	24
LTE B30	TX1	0	100.00%	30.4	29.2	24.7	27	25.8	23.4
LTE 41/38	TX1	0	63.30%	29	27.8	20.4	23.8	22.6	21.5
LTE B38 HPUE	TX1	0	43.30%	29	27.8	20.4	23.8	22.6	21.1
LTE B41 HPUE	TX1	0	43.30%	29	27.8	20.4	23.8	22.6	22
LTE B48	TX1	2	63.30%	32.1	30.9	25	29.3	28.1	19.9
LTE B66	TX1	0	100.00%	29.1	27.9	23.4	24.6	23.4	23.4
LTE B71	TX1	1	100.00%	29.8	28.6	29.7	30.9	29.7	24
FR1 n25/2	TX1	0	100.00%	27.9	26.7	22.3	23.5	22.3	23.6
FR1 n5	TX1	1	100.00%	26.3	25.1	27.9	29.1	27.9	24.1
FR1 n7	TX1	0	100.00%	27.4	26.2	20.8	22	22	23.7
FR1 n12	TX1	1	100.00%	27.6	26.4	29	30.2	29	24.1
FR1 n30	TX1	0	100.00%	28.7	27.5	24.5	27.4	26.2	23.5
FR1 n38	TX1	5	100.00%	21.4	20.2	20.8	22	22	24.2
FR1 n41	TX1	5	100.00%	21.4	20.2	20.8	22	22	24
FR1 n41 HPUE	TX1	5	50.00%	21.4	20.2	20.8	22	22	22.4
FR1 n66	TX1	0	100.00%	29.6	28.4	23.1	24.3	23.1	23.2
FR1 n71	TX1	1	100.00%	28.9	27.7	29.8	31	29.8	24.1
FR1 n77	TX1	2	100.00%	35.9	34.7	27.3	29.7	28.5	22.3
FR1 n77 HPUE	TX1	2	50.00%	35.9	34.7	27.3	29.7	28.5	21

<sup>1.</sup> LTE and 5GNR TDD: Plimit power levels in the table correspond to the time-averaged power levels which accounts for TX duty cycle.

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<sup>2.</sup> Maximum target power, Pmax, is configured in NV settings in EUT to limit maximum transmitting power. This power is converted into peak power in NV settings for TDD schemes.

## 5.2 <u>Test case list for sub-6GHz transmissions</u>

To validate TAS algorithm in various sub-6GHz conditions, the chosen TC (Test Case) list is defined as in Table 5.2.1.

Table 5.2.1 Sub-6GHz TAS validation test case list

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No.	Test Scenario	Test case	Test configuration		
1		LTE_Time_Varying_Tx_Power_Case_1	LTE Band 7		
2		LTE_Time_Varying_Tx_Power_Case_1	LTE Band 25/2		
3	Time-varying Tx power transmission	SA_FR1_Time_Varying_Tx_Power_Case_1	FR1 41 (SA Mode)		
4		SA_FR1_Time_Varying_Tx_Power_Case_1	FR1 25 (SA Mode)		
5	Time-varying 1x power transmission	LTE_Time_Varying_Tx_Power_Case_2	LTE Band 7		
6		LTE_Time_Varying_Tx_Power_Case_2	LTE Band 25/2		
7		SA_FR1_Time_Varying_Tx_Power_Case_2	FR1 41 (SA Mode)		
8	SA_FR1_Time_Varying_Tx_Power_Case_2		FR1 25 (SA Mode)		
9	Change operate states SA_FR1_RF_SAR_Index_Change		FR1 41 (SA Mode)_Index 5 to Index 3		
10	Wireless technology Handover	LTE to WCDMA H.O.	LTE Band 7 to WCDMA 4		
10	TAS to non TAS	ETE_to_WGDIWIA_H.O.	LTE Band 7 to WCDIMA 4		
11	Antenna switch/ Time Window change case 2 100s-60s-100s	LTE_Averaging_Time_Window_Change 2	LTE Band 7 to LTE Band 48		
12	Antenna switch/ Time Window change case 1 60s-100s-60s	LTE_Averaging_Time_Window_Change 1	LTE Band 48 to LTE Band 7		
13	Drop call	Call_Disconnect_Reestablishment	LTE Band 7		
14	SAR exposure switch	NSA_FR1_Dominant_Power_Switching	FR n41 (NSA), LTE Band 25		
15	Re-selection in call	NR_TO_LTE_IRAT_HO	FR1 n41(SA) to LTE Band 7		

## 5.3 Test case list for LTE+FR2 transmissions

To validate TAS algorithm in scenarios including FR2, the chosen TC (Test Case) list is defined as in Table 5.3.1.

Table 5.3.1 Sub-6GHz TAS validation test case list

No.	Test Scenario	Test case	Test configuration			
			B2+n258 Beam 3			
1 Tim	Time-varying Tx power transmission	mmWave_Max_Tx_Power	B2+n260 Beam 3			
			B2+n261 Beam 3			
			B2+n258 Beam 3			
2	SAR exposure switch	mmWave_Dominant_Power_Switching	B2+n260 Beam 3			
	•	_	B2+n261 Beam 3			
			B2+n258 (Beam 3 to Beam 5 to Beam 1)			
3	Change of beam	mmWave_Module_Beam_Change	B2+n260 (Beam 5 to Beam 3 to Beam 1)			
	_	_	B2+n261 (Beam 5 to Beam 3 to Beam 0)			

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# 6. Conducted Power Test Results for Sub-6 TAS validation

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## 6.1 Measurement set-up

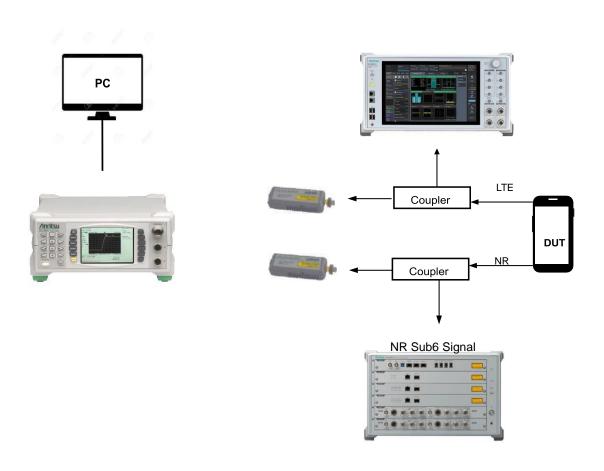


Figure 6.1-1 Test set-up for legacy and sub 6GHz

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The test setup for TAS validation with sub-6GHz RATs only is shown in Figure 6.1-1.

Power readings for each active technology are recorded every 100ms and dumped in an excel file. A post-processing tool is used to extract data from the excel file and plot the required metrics such as time-averaged power, SAR and TER values versus time as described in Section 3.3.

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In summary, the tests have to be executed as following procedure.

- 1. Measure conduction sub 6GHz Tx power corresponds to SAR regulation.
- 2. Execute time-varying test scenarios. And record sub 6GHz power using sub 6GHz power meter equipment.
- 3. The time interval between subsequent conducted power measurements is 0.1s (typically much less than 1 second)
- 4. Plot the recorded results over measurement time. And evaluate the results for validation.
- 5. The required Power level is burst average power level controlled by call box, the power varying measurement correspond to time-average power levels after accounting for duty cycle in the case TDD modulation schemes (e.g. LTE, 5G FR1 TDD bands).

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## 6.2 Measured Plimit and Pmax

The measured *Plimit* for all the selected radio configurations are listed in Table 6.2.1. *Pmax* was also measured for radio configurations selected for testing time-varying Tx power transmission scenario in order to generate test sequences following the test procedures.

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Table 6.2.1 Measured Plimit and Pmax of selected radio configurations

item	Test Scenario	Antenna	Power index	Test band	Mode	BW/RB/offset	Pmax Setting (dBm)	measured Pmax(dBm)	Plimit Setting (dBm)	Measured Plimit (dBm)	Total Uncertainty (dB)
1		TX0_2	4	LTE Band 7	QPSK	20M/1/0	24.5	23.7	20.1	19.9	1
2	Time varying Tx power case 1	TX1_0	4	LTE Band 25	QPSK	20M/1/49	23.6	23.6	22.6	22	1
3	Time varying 1x power case 1	TX0_1	3	FR1 41 (SA Mode)	BPSK	100M/135/69	24.5	23.85	16.3	16.7	1
4		TX1_0	4	FR1 25 (SA Mode)	BPSK	20M/1/53	23.6	23.7	22.3	21.7	1
5		TX0_2	4	LTE Band 7	QPSK	20M/1/0	24.5	23.7	20.1	19.9	1
6	Time varying Tx power case 2	TX1_0	4	LTE Band 25	QPSK	20M/1/49	23.6	23.6	22.6	22	1
7	Time varying 1x power case 2	TX0_1	3	FR1 41 (SA Mode)	BPSK	100M/135/69	24.5	23.85	16.3	16.7	1
8		TX1_0	4	FR1 25 (SA Mode)	BPSK	20M/1/53	23.6	23.7	22.3	21.7	1
9	Change operate states	TX0_1	5	FR1 41 (SA Mode)	BPSK	100M/135/69	24.5	23.85	22.5	22.2	1
9	Change operate states	TX0_1	3	FR1 41 (SA Mode)	BPSK	100M/135/69	24.5	23.85	16.3	16.7	1
10	LTE Handover WCDMA (TAS to non TAS)	TX0_2	4	LTE Band 7	QPSK	20M/1/0	24.5	23.7	20.1	19.9	1
10		TX0_2	4	WCDMA B4	RMC	-	24.3	24.2	22	22.1	1
11	Window change case 1 100s-60s-100s	TX0_2	4	LTE Band 7	QPSK	20M/1/0	24.5	23.7	20.1	19.9	1
11	Willdow Change case 1 100s-60s-100s	TX0_6	4	LTE Band 48	QPSK	20M/1/0	22.5	21.9	21.3	21.9	1
12	Window change case 2 60s-100s-60s	TX0_6	4	LTE Band 48	QPSK	20M/1/0	22.5	21.9	21.3	21.9	1
12	Willidow change case 2 605-1005-605	TX0_2	4	LTE Band 7	QPSK	20M/1/0	24.5	23.7	20.1	19.9	1
13	Change in call	TX0_2	4	LTE Band 7	QPSK	20M/1/0	24.5	23.7	20.1	19.9	1
		TX0_2	4	LTE Band 25	QPSK	20M/1/0	24.5	23.9	21	21.1	1
14	NSA_FR1_Dominant_Power_Switching	TX0_1	4	FR1 41 (NSA Mode)	BPSK	100M/135/69	24.5	23.85	19.9	19.8	1
15	NR_TO_LTE_IRAT_Re-selection	TX0_1	3	FR1 n41 PC3 (SA Mode)	BPSK	100M/135/69	24.5	23.8	19.9	19.7	1
		TX1_0	4	LTE Band 7	QPSK	20M/1/0	23.1	23.1	21	20.9	1

Note that the EUT has multiple power indexes to manage the output power for different conditions corresponding to RF exposure conditions in above table, detailed power index trigger conditions are illustrated in the operational description, and 1g and 10g SAR design target are shown in the part 0 report.

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TC#	Test Scenario	Antenna	Polarization	Power index	Test band	Mode	BW/RB/offset	Pmax Stting (dBm)	measured Pmax (dBm)	Plimit Setting (dBm)	Measured Plimit (dBm)	Measured EIRP (dBm)	Device Uncertainty (dB)
1	Time-varying Tx power	2	-	4	LTE Band 2	QPSK	20M/1/0	24.5	24.6	21	21.05	-	1
'	transmission	Plane B	H+V	1	FR2 n258	QPSK	100M/1/0	1	-	8.81	-	11.63	2.3
2	SAR exposure switch	2	-	4	LTE Band 2	QPSK	20M/1/0	24.5	24.6	21	21.05	-	1
		Plane B	H+V	-	FR2 n258	QPSK	100M/1/0	ı	-	8.81	-	11.63	2.3
		Plane B	H+V	-	FR2 n258	QPSK	100M/1/0	1	-	8.81	-	11.63	2.3
3	Change of beam	Plane B	H+V		FR2 n258	QPSK	100M/1/0	1	-	8.81	-	9.65	2.3
		Plane B	H+V		FR2 n258	QPSK	100M/1/0	1	-	8.81	-	9.6	2.3
4	Time-varying Tx power transmission	2	-	4	LTE Band 2	QPSK	20M/1/0	24.5	24.6	21	21.05	-	1
4		Plane B	H+V	-	FR2 n260	QPSK	100M/1/0	ı	-	11.37	-	15.55	2.3
5	SAR exposure	2	•	4	LTE Band 2	QPSK	20M/1/0	24.5	24.6	21	21.05	-	1
5	switch	Plane B	H+V	-	FR2 n260	QPSK	100M/1/0	-	-	11.37	-	15.55	2.3
		Plane B	H+V	-	FR2 n260	QPSK	100M/1/0	1	-	11.37	-	14.35	2.3
6	Change of beam	Plane B	H+V	-	FR2 n260	QPSK	100M/1/0	-	-	11.37	-	15.55	2.3
		Plane B	H+V	-	FR2 n260	QPSK	100M/1/0	-	-	11.37	-	14.11	2.3
7	Time-varying Tx power	2	-	4	LTE Band 2	QPSK	20M/1/0	24.5	24.6	21	21.05	-	1
,	transmission	Plane B	H+V	-	FR2 n261	QPSK	100M/1/0	ı	-	9.1	-	12.55	2.3
8	SAR	2		4	LTE Band 2	QPSK	20M/1/0	24.5	24.6	21	21.05	-	1
0	exposure switch	Plane B	H+V	-	FR2 n261	QPSK	100M/1/0	-	-	9.1	-	12.55	2.3
		Plane B	H+V	-	FR2 n261	QPSK	100M/1/0	-	-	9.1	-	10.36	2.3
9	Change of beam	Plane B	H+V	-	FR2 n261	QPSK	100M/1/0	-	-	9.1	-	12.55	2.3
	200	Plane B	H+V	-	FR2 n261	QPSK	100M/1/0	-	-	9.1	-	11.23	2.3

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Plimit setting which can be referenced from Part 0 report is for single polarization, so the dual-pol EIRP target is equivalent to Plimit plus 3dB.

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# 6.2.1 Sub-6 summary test results

item	Test Scenario	Antenna	Power index	Test band	Mode	BW/RB/offset	1g SAR design target (W/kg)	1g Time-average SAR (W/kg)	Deviation (dB)	Total Uncertainty (dB)
1		TX0_2	4	LTE Band 7	QPSK	20M/1/0	0.72	0.803	0.47	1
2	Time varying Tx power case 1	TX1_0	4	LTE Band 25/2	QPSK	20M/1/49	0.72	0.686	-0.21	1
3	Time varying 1x power case 1	TX0_1	3	FR1 41 (SA Mode)	BPSK	100M/135/69	0.72	0.715	-0.03	1
4		TX1_0	4	FR1 25 (SA Mode)	BPSK	20M/1/53	0.72	0.736	0.10	1
5		TX0_2	4	LTE Band 7	QPSK	20M/1/0	0.72	0.653	-0.42	1
6	Time varying Tx power case 2	TX1_0	4	LTE Band 25/2	QPSK	20M/1/49	0.72	0.642	-0.50	1
7	Time varying 1x power case 2	TX0_1	3	FR1 41 (SA Mode)	BPSK	100M/135/69	0.72	0.698	-0.13	1
8		TX1_0	4	FR1 25 (SA Mode)	BPSK	20M/1/53	0.72	0.688	-0.20	1
9	Change aparete states	TX0_1	5	FR1 41 (SA Mode)	BPSK	100M/135/69	0.95	0.781	-0.85	1
9	Change operate states	TX0_1	3	FR1 41 (SA Mode)	BPSK	100M/135/69	0.72	0.781	-0.85	1
10	LTE Handover WCDMA (TAS to non	TX0_2	4	LTE Band 7	QPSK	20M/1/0	0.72	0.731	0.07	1
10	TAS)	TX0_2	4	WCDMA B4	RMC	-	0.72	0.731	0.07	1
11	Window change case 1 100s-60s-100s	TX0_2	4	LTE Band 7	QPSK	20M/1/0	0.72	0.786	0.38	1
' '	Window change case 1 100s-60s-100s	TX0_6	4	LTE Band 48	QPSK	20M/1/0	0.72	0.786	0.36	1
40	Window share and 200 400 00	TX0_6	4	LTE Band 48	QPSK	20M/1/0	0.72	0.707	0.00	1
12	Window change case 2 60s-100s-60s	TX0_2	4	LTE Band 7	QPSK	20M/1/0	0.72	0.787	0.39	1
13	Change in call	TX0_2	4	LTE Band 7	QPSK	20M/1/0	0.72	0.671	-0.31	1
4.4	NICA EDA Descisarat Description	TX0_2	4	LTE Band 25	QPSK	20M/1/0	0.72	0.700	0.05	1
14	14 NSA_FR1_Dominant_Power_Switching	TX0_1	4	FR1 41 (SA Mode)	BPSK	100M/135/69	0.72	0.763	0.25	1
15	NR_TO_LTE_IRAT_Re-selection	TX0_1	3	FR1 n41 PC3 (SA Mode)	BPSK	100M/135/69	0.72	0.696	-0.15	1
		TX1_0	4	LTE Band 7	QPSK	20M/1/0	0.72			1

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item	Test Scenario	Antenna	Power index	Test band	Mode	BW/RB/offset	1g SAR design target (W/kg)	PD design target (Mw/cm^2)	TER	PD design target + total uncertainty	Total Uncertainty (dB)
4	Time-varying Tx 1 power transmission 1	2	4	LTE Band 2	QPSK	20M/1/0	0.72	-	0.649	0.75	2.3
1			1	N258	QPSK	100M/1/0	-	4.42			
2	2 SAR exposure switch	2	4	LTE Band 2	QPSK	20M/1/0	0.72	-	0.591	0.75	2.3
2			-	N258	QPSK	100M/1/0	-	4.42			
3	Change of beam	2	4	LTE Band 2	QPSK	20M/1/0	0.72	-	0.508	0.75	2.3
3			-	N258	QPSK	100M/1/0	-	4.42			
4	Time-varying Tx power transmission 1	2	4	LTE Band 2	QPSK	20M/1/0	0.72	-	0.714	0.75	2.3
4			-	N260	QPSK	100M/1/0	-	4.42			
5	SAR exposure switch	2	4	LTE Band 2	QPSK	20M/1/0	0.72	-	0.741	0.75	2.3
3			-	N260	QPSK	100M/1/0	-	4.42			
6	Change of beam	2	4	LTE Band 2	QPSK	20M/1/0	0.72	-	0.609	0.75	2.3
O	Change of beam		•	N260	QPSK	100M/1/0	-	4.42			
7	Time-varying Tx power transmission 1	2	4	LTE Band 2	QPSK	20M/1/0	0.72	-	0.678	0.75	2.3
,			-	N261	QPSK	100M/1/0	-	4.42			
8	SAR exposure switch	2	4	LTE Band 2	QPSK	20M/1/0	0.72	-	0.582	0.75	2.3
8			-	N261	QPSK	100M/1/0	-	4.42			
9	Change of beam	2	4	LTE Band 2	QPSK	20M/1/0	0.72	-	0.629	0.75	2.3
Э			-	N261	QPSK	100M/1/0	-	4.42			

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## 6.3 <u>Time-varying Tx power measurement results</u>

Following the test procedure in Section 3.3, the conducted Tx power measurement results for all selected test cases are listed in this section. In all conducted Tx power plots, the blue line shows the measured instantaneous power using the power meter, the red line shows the time-averaged Tx power and yellow line shows the Plimit value corresponding to design target. In all SAR plots, the dotted blue line shows the time-averaged 1gSAR while the red line shows the corresponding FCC limit of 1.6W/Kg. Time-varying Tx power measurements were conducted for TC #1-8 in Table 5.2.1 by generating the test sequence A or B given in Appendix.

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# 6.3.1 TC01: LTE Band 7\_Time\_Varying\_Tx\_Power\_Case\_1 10 0 -20 Measured LTE inst.power -30 Measured LTE 100s-avg.power Power limit for SAR\_design\_target ····· Required power level 300 0 100 200 400 500 600

Figure 6.3-1 Time average conducted power

Time (s)

Figure 6.3-1 shows the conducted Tx power plot with calculated time-averaged power based on the measured instantaneous Tx power with 1gSAR FCC Limit value. As shown in Figure 6.3-1, it is confirmed for time- average Tx power that the FCC limit was not exceeded, and that the averaged Tx power is smaller than the target power, and it will saturate to target power with little margin. Figure 6.3-2 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

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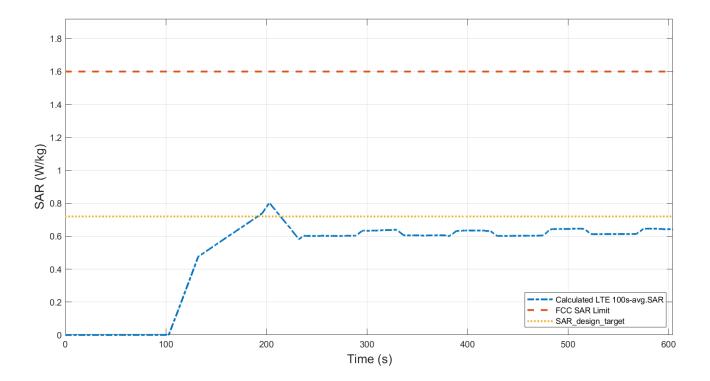


Figure 6.3-2 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg		
Max 100s-time average 1gSAR (blue curve)	0.803 W/kg		
Device uncertainty	1 dB		

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#### 6.3.2 TC02: LTE Band 25\_Time\_Varying\_Tx\_Power\_Case\_1

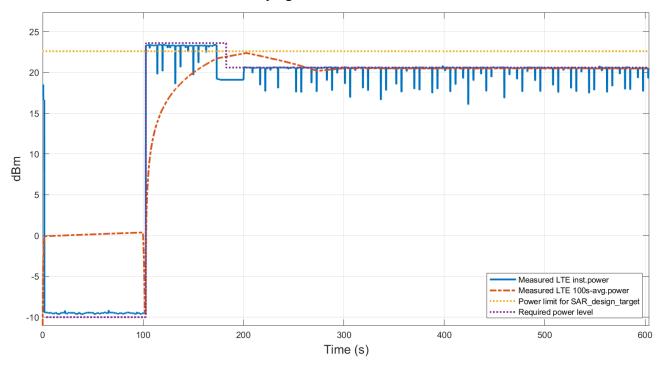


Figure 6.3-3 Time-average conducted power

Figure 6.3-3 shows the instantaneous and time-averaged Tx power for this test. As shown in Figure 6.3-3, it is confirmed for time-average Tx power that the FCC limit was not exceeded, and that the averaged Tx power is lower than the value of Plimit. Figure 6.3-4 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

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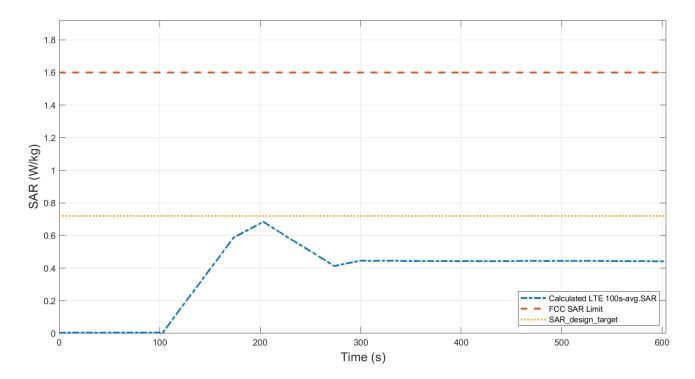


Figure 6.3-4 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg		
Max 100s-time average 1gSAR (blue curve)	0.686 W/kg		
Device uncertainty	1 dB		

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## 6.3.3 TC03: FR1 n41 SA mode\_Time\_Varying\_Tx\_Power\_Case\_1

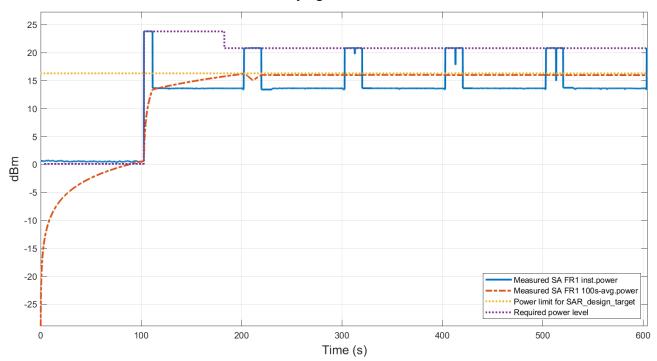


Figure 6.3-5 Conducted Tx power

Figure 6.3-5 shows the instantaneous and time-averaged Tx power with test sequence B. Figure 6.3-6 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

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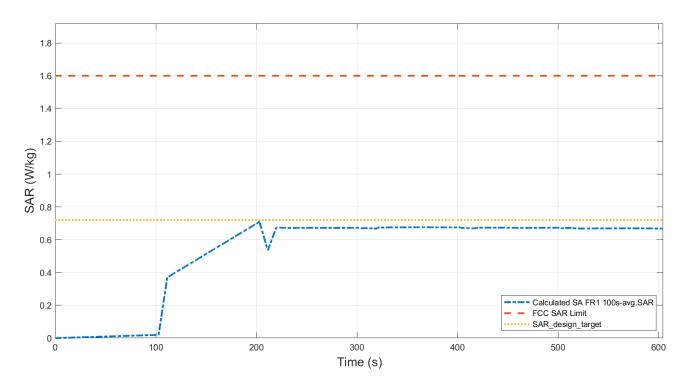


Figure 6.3-6 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg		
Max 100s-time average 1gSAR (blue curve)	0.715 W/kg		
Device uncertainty	1 dB		

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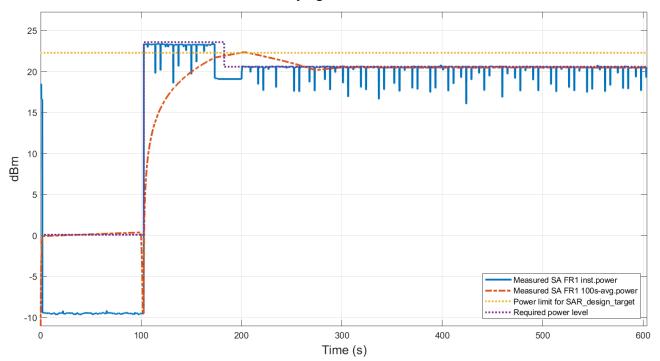


Figure 6.3-7 Conducted Tx power

Figure 6.3-7 shows the instantaneous and time-averaged Tx power with test sequence B. Figure 6.3-8 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

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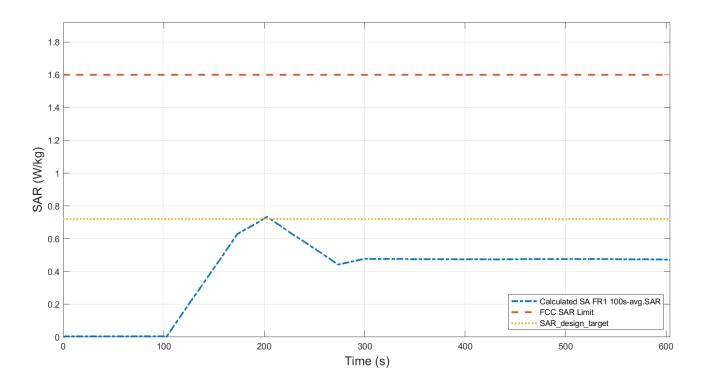


Figure 6.3-8 Total time-averaged SAR in F\_TC04

FCC 1gSAR limit	1.6 W/kg
Max 100s time average 1gSAR (blue curve)	0.736 W/kg
Device uncertainty	1 dB

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# 6.3.5 TC05: LTE band 7\_Time\_Varying\_Tx\_Power\_Case\_2

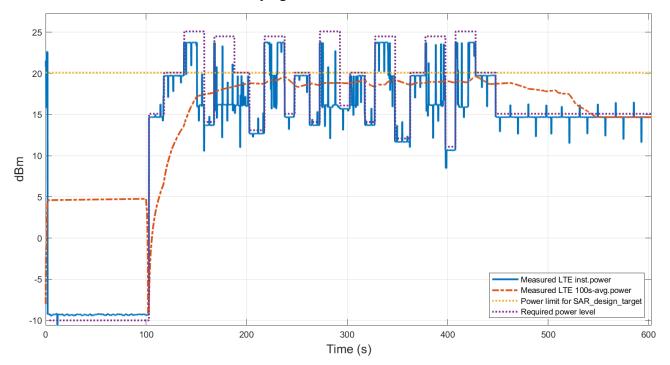


Figure 6.3-9 Conducted Tx power

Figure 6.3-9 shows the instantaneous and time-averaged Tx power with test sequence B. Figure 6.3-10 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

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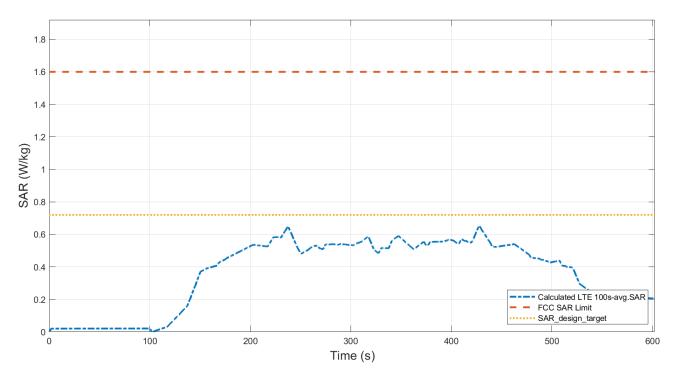
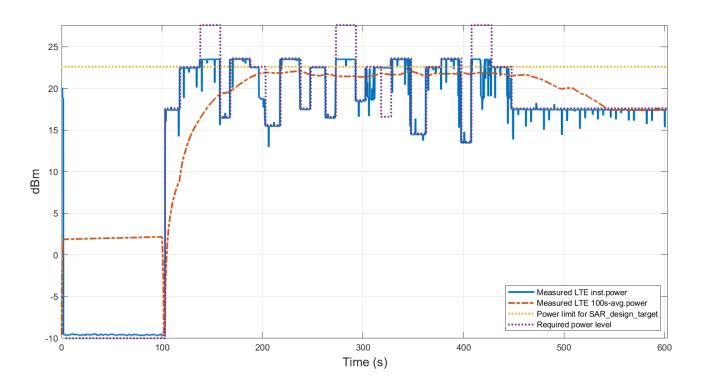


Figure 6.3-10 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max 100s time average 1gSAR (blue curve)	0.653 W/kg
Device uncertainty	1 dB

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Figure 6.3-11 Conducted Tx power

Figure 6.3-11 shows the instantaneous and time-averaged Tx power with test sequence B. Figure 6.3-12 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

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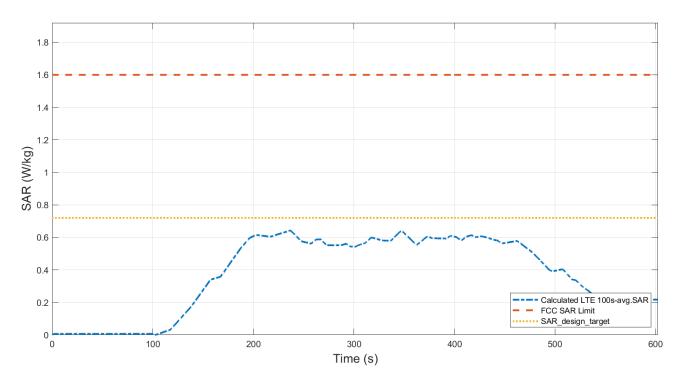
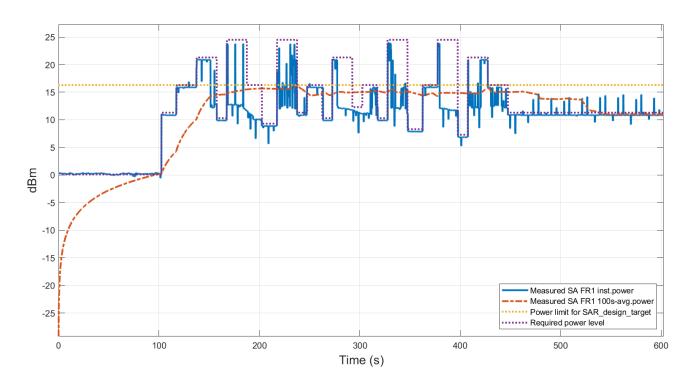


Figure 6.3-12 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max 100s time average 1gSAR (blue curve)	0.642 W/kg
Device uncertainty	1 dB

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# 6.3.7 TC07: FR1 n41 SA mode \_Time\_Varying\_Tx\_Power\_Case\_2



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Figure 6.3-13 Conducted Tx power

Figure 6.3-13 shows the instantaneous and time-averaged Tx power with test sequence B. Figure 6.3-14 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

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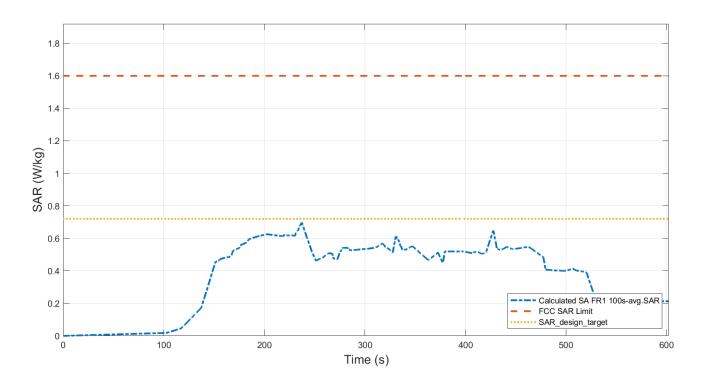


Figure 6.3-14 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max 100s time average 1gSAR (blue curve)	0.698 W/kg
Device uncertainty	1 dB

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# 6.3.8 TC08: FR1 n25 SA mode\_Time\_Varying\_Tx\_Power\_Case\_2

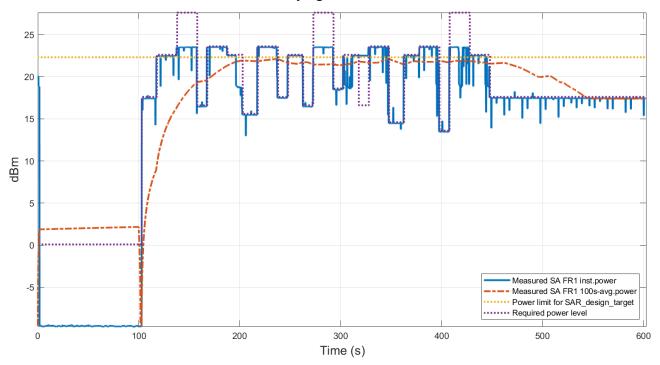


Figure 6.3-15 Conducted Tx power

Figure 6.3-15 shows the instantaneous and time-averaged Tx power with test sequence B. Figure 6.3-16 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

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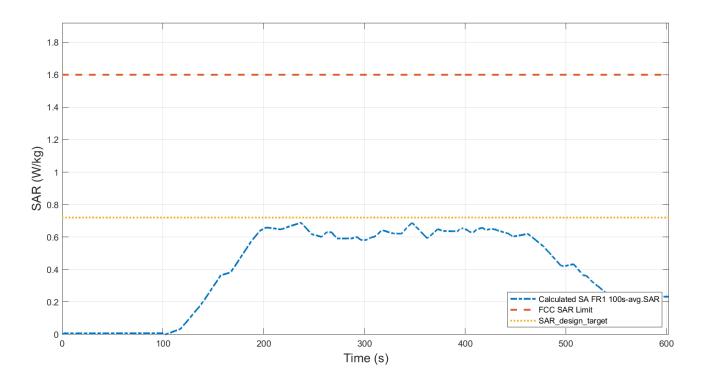


Figure 6.3-16 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max 100s time average 1gSAR (blue curve)	0.688 W/kg
Device uncertainty	1 dB

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# 6.4 Change operate states

The test results in this section are obtained following the procedure in Section 3.3.2. The test cases correspond to TC#09 in Table 5.2.1.

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#### 6.4.1 TC9: SA\_FR1 n41\_RF\_SAR\_Index\_Change

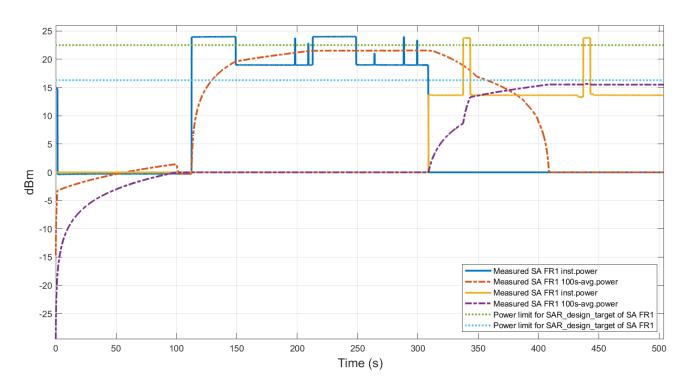


Figure 6.4-1 Conducted Tx power for SAR states change

Figure 6.4-1 shows the instantaneous and time-averaged conducted Tx power for both SA FR1 Band n41 for the duration of the test. Around time stamp of ~330s, the RFI value is changed from power index 5 to power index 3, resulting in reduction of target time-averaged power of SA FR1 Band n41. It can be seen that Plimit value of power index 3 is lower than that of power index 5, so in power index 3 region, more Tx power is limited compared to power index 5 region. Figure 6.4-2 shows the time-averaged 1gSAR value for each of power index 3 and power index 5 value, as well as the total SAR value. We can see that the total 1gSAR is higher during the band transitions, but is always under the total FCC limit of 1.6W/Kg.

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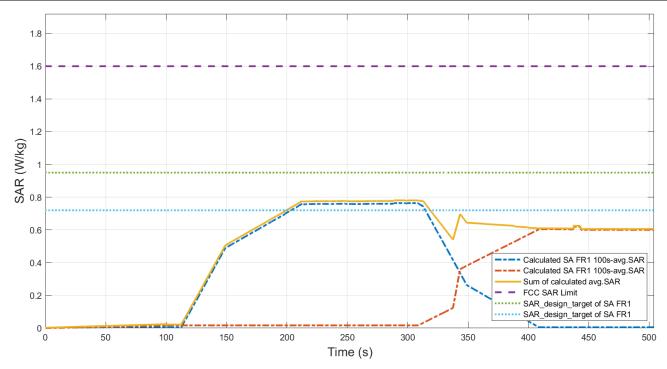


Figure 6.4-2 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max sum of calculated average SARs (yellow curve)	0.781 W/kg
Device uncertainty	1 dB

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# 6.5 LTE Handover WCDMA results

The test results in this section are obtained following the procedure in Section 3.3.2. The test cases correspond to TC#10 in Table 5.2.1.

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#### 6.5.1 TC10: TAS to nonTAS H.O.

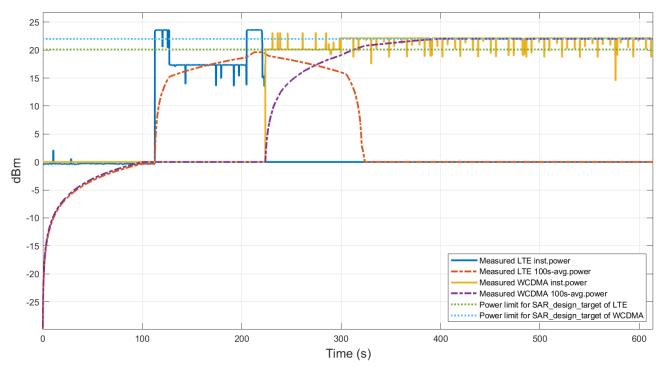


Figure 6.5-1 Conducted Tx power for SAR TAS to nonTAS H.O

Figure 6.5-1 shows the instantaneous and time-averaged conducted Tx power for both LTE Band 7 and WCDMA Band 4 for the duration of the test. Around time stamp of ~220s, a handover from LTE Band 7 to WCDMA Band 4 was executed, resulting in reduction of time-averaged power of LTE Band 7 and simultaneous increase in time- averaged power of WCDMA Band 4. Because WCDMA is nonTAS RAT, it always transmits maximum power. But when remaining SAR value is low after handover, nonTAS would limit the Tx power for a second to satisfy SAR compliance. Figure 6.5-2 shows the time-averaged 1gSAR value for each of LTE Band 7 and WCDMA Band 4, as well as the total SAR value. We can see that the total 1gSAR is higher during the band transitions, but is always under the total FCC limit of 1.6W/Kg.

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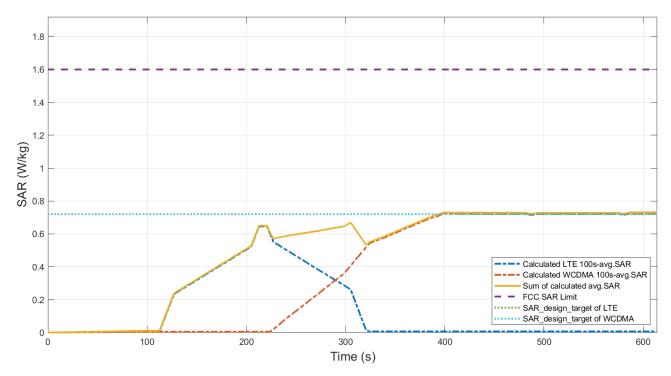


Figure 6.5-2 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max sum of calculated average SARs (yellow curve)	0.732 W/kg
Device uncertainty	1 dB

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# 6.6 Change in band/time-window test results

The test results in this section are obtained following the procedure in Section 3.3.2. The test cases correspond to TC#11-12 in Table 5.2.1.

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#### 6.6.1 TC11: LTE\_Averaging\_Time\_Window\_Change\_1 (LTE Band 7 ant 2 to LTE Band 48 ant 6)

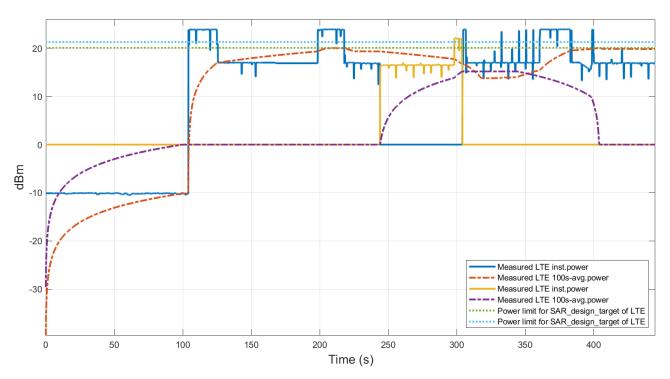


Figure 6.6-1 Conducted Tx power for SAR windowchange

Figure 6.6-1 shows the instantaneous and time-averaged conducted Tx power for both LTE Band 7 and Band 48 for the duration of the test. Around time stamp of ~240s, a handover from Band 7 to Band 48 was executed, resulting in reduction of time-averaged power of Band 7 and simultaneous increase in time-averaged power of Band 48. Around time stamp of ~300s, handover back to Band 7 was executed, resulting in reduction of time-averaged power of Band 48 and increase of time-averaged power of Band 7. It can be seen that transition time of time-averaged values for Band 7 is longer than Band 48, which is the consequence of 100s time- averaging for Band 7 versus shorter 60s averaging for Band 48. Figure 6.6-2 shows the time-averaged 1gSAR value for each of Band 7 and Band 48, as well as the total SAR value. We can see that the total 1gSAR is higher during the band transitions, but is always under the total FCC limit of 1.6W/Kg.

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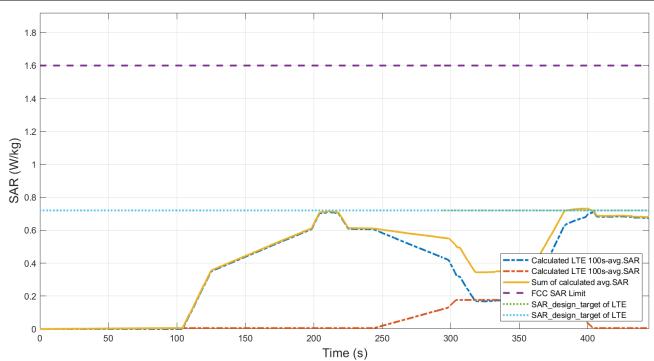


Figure 6.6-2 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max sum of calculated average SARs (yellow curve)	0.786 W/kg
Device uncertainty	1 dB

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#### 6.6.2 TC12: LTE\_Averaging\_Time\_Window\_Change\_2 (LTE Band 48 ant 6 to LTE Band 7 ant 2)

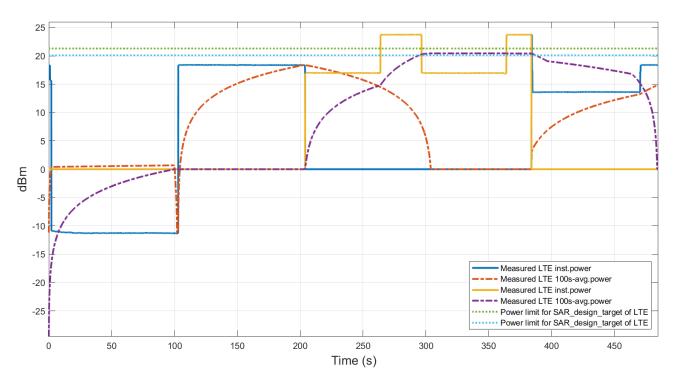


Figure 6.6-3 Conducted TxPower in SAR Window Change test

Figure 6.6-3 shows the instantaneous and time-averaged conducted Tx power for both LTE Band 7 and Band 48 for the duration of the test. Around time stamp of ~200s, a handover from Band 48 to Band 7 was executed, resulting in reduction of time-averaged power of Band 48 and simultaneous increase in time-averaged power of Band 7. Around time stamp of ~380s, handover back to Band 48 was executed, resulting in reduction of time-averaged power of Band 7 and increase of time-averaged power of Band 48. It can be seen that transition time of time-averaged values for Band 7 is longer than Band 48, which is the consequence of 100s time- averaging for Band 7 versus shorter 60s averaging for Band 48. Figure 6.6-4 shows the time-averaged 1gSAR value for each of Band 7 and Band 48, as well as the total SAR value. We can see that the total 1gSAR is higher during the band transitions, but is always under the total FCC limit of 1.6W/Kg.

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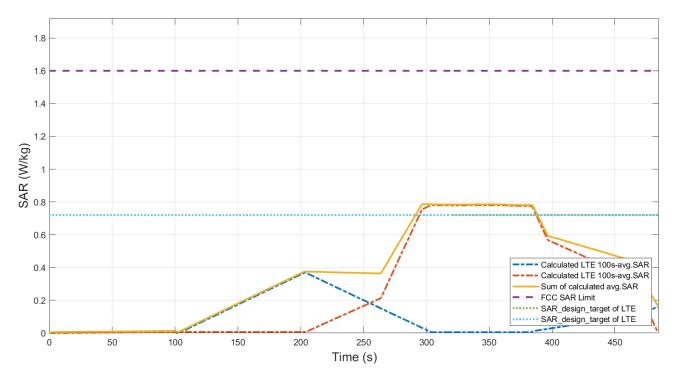


Figure 6.6-4 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max sum of calculated average SARs (yellow curve)	0.787 W/kg
Device uncertainty	1 dB

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# 6.7 Change in call test results

The test results in this section are obtained following the procedure in Section 3.3.1. The test case corresponds to TC#13 in Table 5.2.1.

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#### 6.7.1 TC13: LTE Band 7\_Call\_Disconnect\_Reestablishment

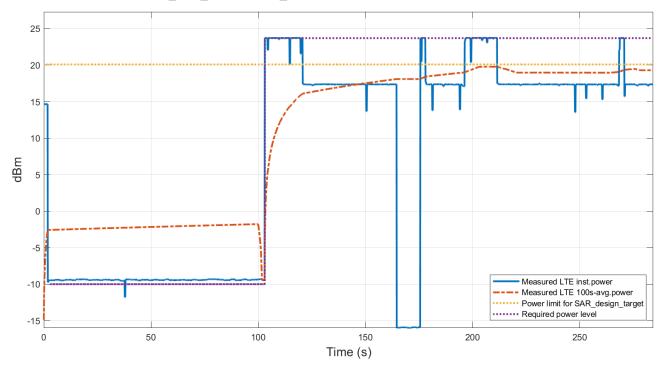


Figure 6.7-1 Conducted Tx power in Call\_Disconnect\_Reestablishment

Figure 6.7-1 shows the instantaneous and time-averaged Tx power for this test. The call disconnected around 170s and resumed after 10s. It is confirmed for time-average Tx power that the FCC limit was not exceeded, and that the averaged Tx power is lower than the value of Plimit. Figure 6.7-2 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg. Looking at the results, it can be seen that even if transmission is stopped due to a call drop, the SAR value measured for a period of time window is stored in the window section and is continuously checked.

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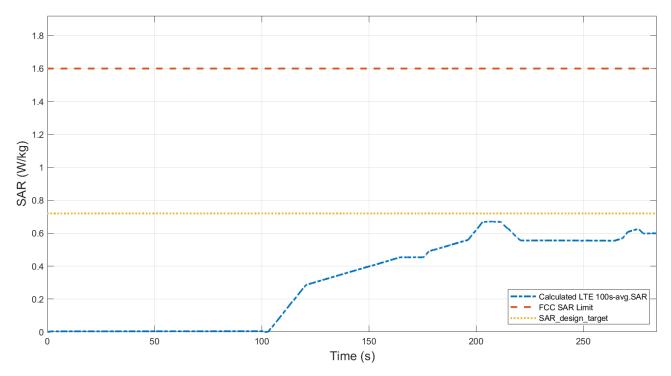


Figure 6.7-2 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max 60s time average 1gSAR (blue curve)	0.671 W/kg
Device uncertainty	1 dB

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# 6.8 Switch in SAR exposure test results

The test results in this section are obtained following the procedure in Section 3.3.2. The test cases correspond to TC#14 in Table 5.2.1.

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#### 6.8.1 TC14: NSA\_FR1\_Dominant\_Power\_Switching (ENDC LTE Band 25\_n41)

In this LTE Band 25+FR1 n41 NSA scenario, we first establish LTE and NR call. In the first part of test, LTE is sent to lowest transmit power using "ALL DOWN" power control commands from call box while NR is sent to maximum power using "ALL UP" power control commands from call box. This would correspond to FR1 dominant SAR scenario and lasts about 110s. In the second part of test, LTE is sent "ALL UP" commands and transmissions are continued, resulting in LTE+FR1 SAR scenario lasting another 110s. In the third part of test, NR is sent "ALL DOWN" power control commands so that it becomes an FR1 dominant SAR scenario for 110s. Finally, both LTE and NR connections are released.

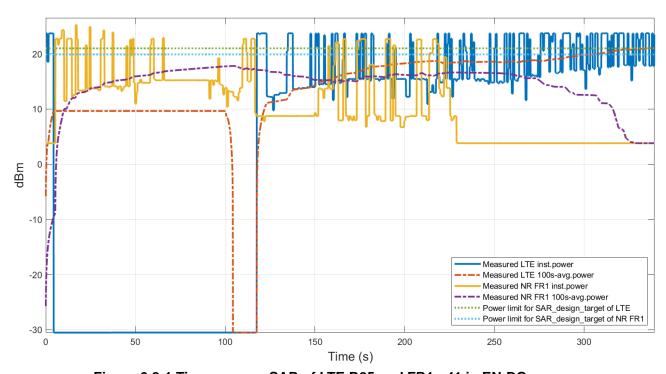


Figure 6.8-1 Time average SAR of LTE B25 and FR1 n41 in EN-DC case

Figure 6.8-1 shows the instantaneous and time-averaged Tx power for both LTE band B25 and NR FR1 band n41 versus time. When both LTE and FR1 operate, the SAR value was the highest instantaneously, but it can be seen that sum of average power in LTE and FR1 decreases again as soon as it is turned off. Figure 6.8-2 shows the computed time-averaged SAR value for LTE and FR1 as well as the sum. It was confirmed that algorithm operated under the SAR design target + total uncertainty, while also being under the FCC limit of 1.6W/Kg at all times. After the operation of FR1 is turned off, it can also be seen that the average power of LTE increases.

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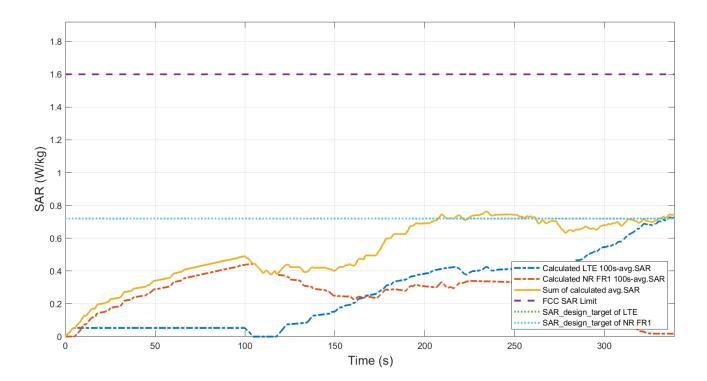


Figure 6.8-2 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max sum of calculated average SARs (yellow curve)	0.763 W/kg
Device uncertainty	1 dB

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# 6.9 Re-selection in call test results

The test results in this section are obtained following the procedure in Section 3.3.2. The test cases correspond to TC#15 in Table 5.2.1.

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#### 6.9.1 TC15: FR1 n41 to LTE Band 7 IRAT Re-selection

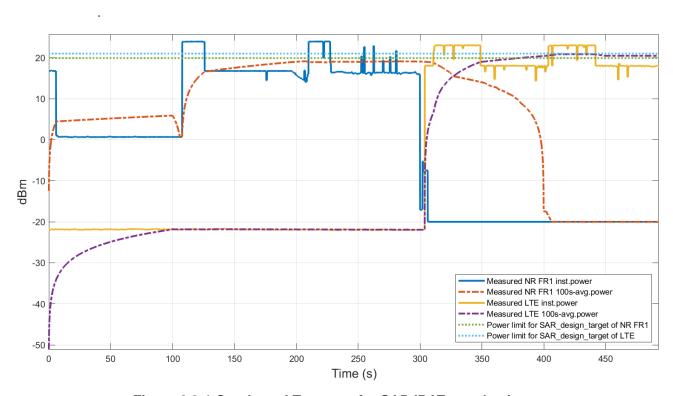


Figure 6.9-1 Conducted Tx power for SAR IRAT re-selection

Figure 6.9-1 shows the instantaneous and time-averaged conducted Tx power for both LTE Band 7 and NR FR1 Band n41 for the duration of the test. Around time stamp of ~310s, a RAT re-selection from LTE Band 7 to NR FR1 Band n41 was executed, resulting in reduction of time-averaged power of Band 25 and simultaneous increase in time-averaged power of Band n41. Figure 6.9-2 shows the time-averaged 1gSAR value for each of LTE Band 7 and NR FR1 Band n41, as well as the total SAR value. We can see that the total 1gSAR is higher during the band transitions, but is always under the total FCC limit of 1.6W/Kg.

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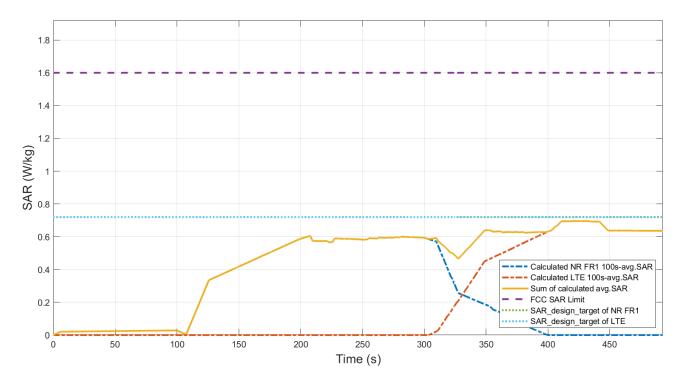


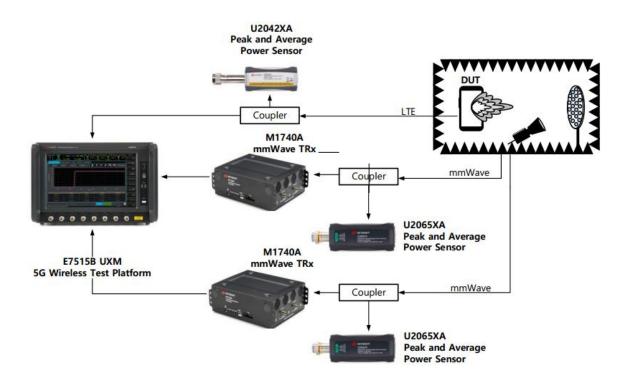
Figure 6.9-2 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max sum of calculated average SARs (yellow curve)	0.696 W/kg
Device uncertainty	1 dB

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# 7. FR2 Radiated power Test Results for TAS validation

### 7.1 Measurement setup



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Figure 7.1-1 Test set-up for mmWave

In mmWave technology, we are not able to measure conducted power at antenna, so only radiated power in the form of EIRP (equivalent isotropically radiated power) will be measured in an anechoic chamber. The test setup is illustrated in Figure 7.1-1. For NSA (non-standalone) operation, legacy LTE technology will also be active and this connection can be done via a connected port of the DUT. A power sensor can be coupled to the LTE transmission. There is a concept of two orthogonal polarization measurements (horizontal and vertical) in mmWave, and so two additional power sensors are needed to measure both. There are remote radio-heads required to performance up/down-conversion of the mmWave signal from/to the call box. The Keysight UXM call box is capable of establishing both LTE and FR2 connections. The coupled power sensors in mmWave uplink will be logged along with the LTE power simultaneously for post-processing on the PC. The LTE power is then mapped to SAR, while the mmWave power readings will be mapped to PD using the characterization data. The direction of DUT is set to see the worst case corresponding to module and beam showing the highest PD in characterization as described in Section 4.3. By validation in this conservative worst PD case, all other cases can be regarded as to be validated as well.

In summary, PD test has to be executed as following procedure (more detailed procedure in Section 4.3).

 Measure conduction sub 6GHz Tx power corresponds to SAR regulation and measure Tx EIRP corresponds to PD regulation. For mmWave, E-field PD measurement TE is used instead of EIRP measurements.

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- 2. Set sub 6GHz and mmWave power level with some margin. And start the test.
- 3. Execute time-varying test scenarios. And record sub 6GHz power using sub 6GHz power meter equipment and EIRP value using mmWave power meter.
- 4. Plot the recorded results over measurement time. And evaluate the results for validation.

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## 7.2 Time-varying Tx power measurement results

The results in this section were obtained following the procedure in Section 6.2 and corresponds to the test case I\_TC01 in Table 6.2.1.

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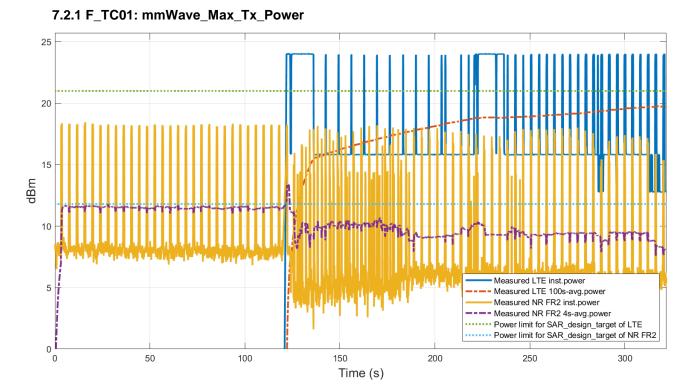


Figure 7.2-1 Conducted power of LTE B2 and radiated EIRP of FR2 n258 in EN-DC max power

Figure 7.2-1 shows the instantaneous and time-averaged conducted power for LTE and radiated power for NR FR2. In this test, we assumed that Plimit value for LTE is 21dBm when SAR\_design target is 0.72W/Kg, and the Plimit value of FR2 is 8.81dBm when PD\_design\_target is 4.42W/m2. When LTE is operated, FR2 power would be decreased to maintain TER value. After the average power of LTE is saturated as target power, the average power of FR2 is not decreased any more. As a result, although LTE is turned on, the TER value doesn't increase or decrease. Figure 7.2-2 shows the computed normalized and time-averaged SAR and PD values for LTE and NR FR2, respectively, as well as their sum which is the TER value. We can see that the TER is always under the FCC compliance limit of 1, thus validating the TAS feature in this test case.

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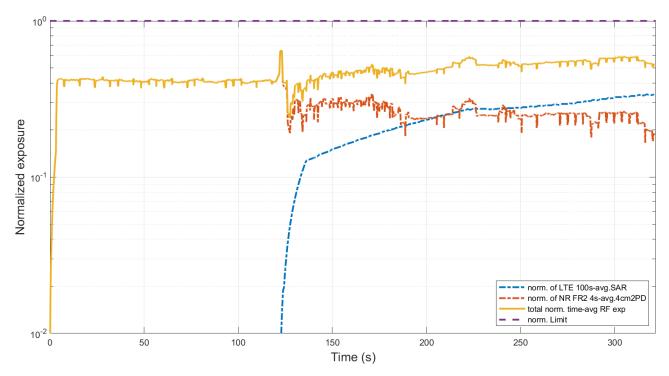


Figure 7.2-2 Total normalized time-average RF exposure in F\_TC01

FCC requirement for total RF exposure (normalized)	1.0	
Max total normalized time-averaged RF exposure (yellow curve)	0.649	
Validated		

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## 7.3 SAR vs. PD exposure switch

The results in this section were obtained following the procedure in Section 6.2 and corresponds to the test case F\_TC02 in Table 6.2.1.

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#### 7.3.1 F\_TC02: mmWave\_Dominant\_Power\_Switching

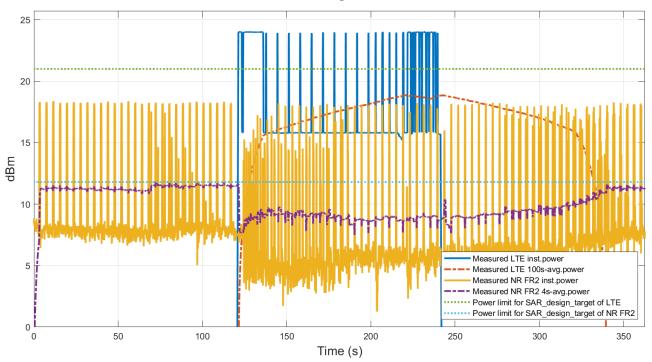


Figure 7.3-1 Conducted power of LTE B2 and radiated EIRP of FR2 n258 in EN-DC max power case

Figure 7.3-1 shows the instantaneous and time-averaged conducted power for LTE and radiated power for NR FR2. In this test, we assumed that Plimit value for LTE is 20dBm when SAR\_design target is 0.72W/Kg, and the Plimit value of FR2 is 8.81dBm when PD\_design\_target is 4.42W/m2. When LTE is operated, FR2 power would be decreased to maintain TER value. After the average power of LTE is saturated as target power, the average power of FR2 is not decreased any more. After LTE is turned off, the average power of FR2 is increased to restore the original target power. As a result, whether LTE is turned on or not, the TER value dramatically doesn't increase or decrease. Figure 7.3-2 shows the computed normalized and time-averaged SAR and PD values for LTE and NR FR2, respectively, as well as their sum which is the TER value. We can see that the TER is always under the FCC compliance limit of 1, thus validating the TAS feature in this test case.

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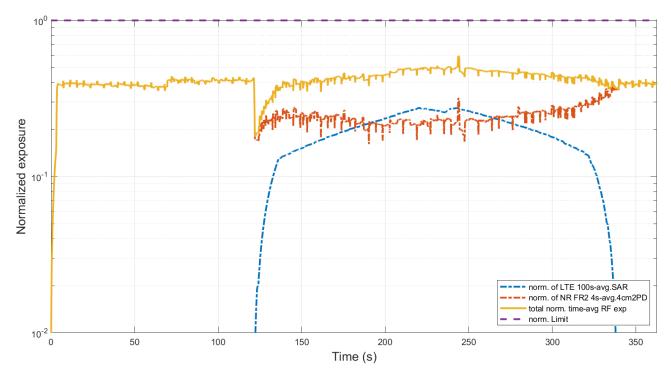


Figure 7.3-2 Total normalized time-average RF exposure in F\_TC02

FCC requirement for total RF exposure (normalized)	1.0	
Max total normalized time-averaged RF exposure (yellow curve)	0.591	
Validated		

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# 7.4 FR2 beam change

The results in this section were obtained following the procedure in Section 6.2 and corresponds to the test case F\_TC03 in Table 6.2.1.

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#### 7.4.1 F\_TC03: mmWave\_Module\_Beam\_Change

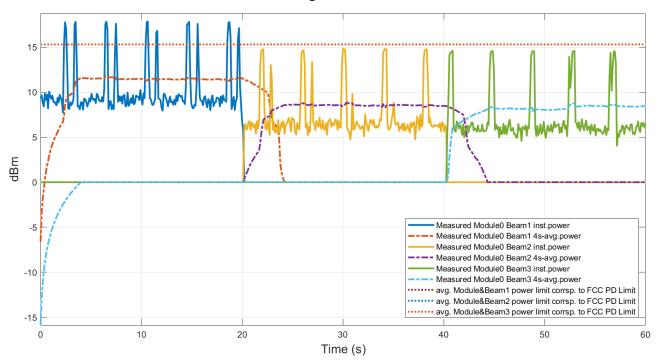


Figure 7.4-1 Measured radiated EIRP of FR2 n258 in mmWave Module beam change case F\_TC03

Figure 7.4-1 shows the instantaneous and time-averaged radiated power for NR FR2. We don't show the LTE transmit power, since it would be at the lowest level and doesn't meaningfully contribute to the TER. In this test, we assumed that the Plimit value of FR2 is 8.81dBm when PD\_design\_target is 4.42W/m2. Figure 7.4-2 shows the computed time-averaged PD for each selected module/beam setting as well as the total sum. When beam or module of FR2 would be changed, the sum of each beam/module is not higher than the target power limit. As a result, whether beam/module is changed or not, the TER value dramatically doesn't increase.

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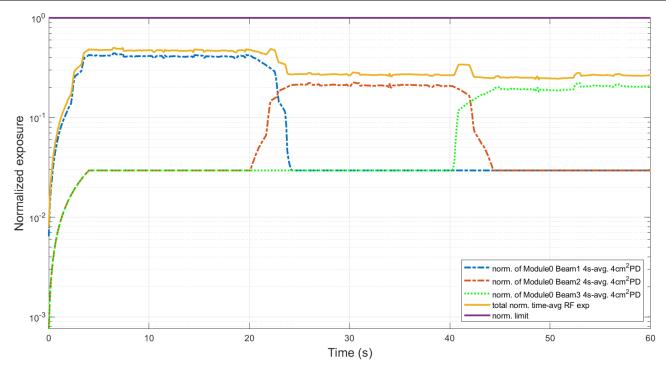


Figure 7.4-2 Total normalized time-average RF exposure

FCC requirement for total RF exposure (normalized)	1.0	
Max total normalized time-averaged RF exposure (yellow curve)	0.508	
Validated		

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# 7.5 Time-varying Tx power measurement results

The results in this section were obtained following the procedure in Section 6.2 and corresponds to the test case I\_TC04 in Table 6.2.1.

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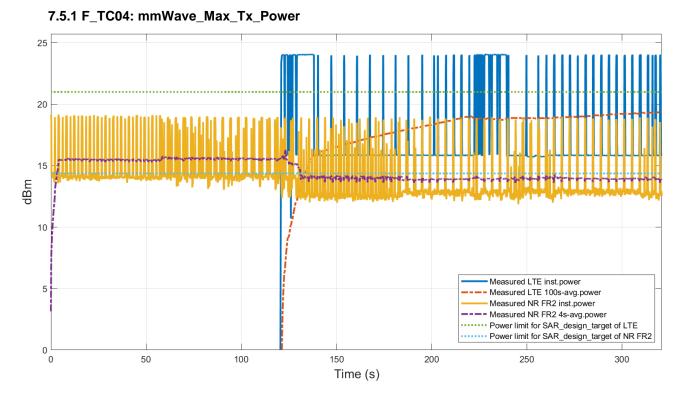


Figure 7.5-1 Conducted power of LTE B2 and radiated EIRP of FR2 n260 in EN-DC max power

Figure 7.5-1 shows the instantaneous and time-averaged conducted power for LTE and radiated power for NR FR2. In this test, we assumed that Plimit value for LTE is 21dBm when SAR\_design target is 0.72W/Kg, and the Plimit value of FR2 is 11.37dBm when PD\_design\_target is 4.42W/m2. When LTE is operated, FR2 power would be decreased to maintain TER value. After the average power of LTE is saturated as target power, the average power of FR2 is not decreased any more. As a result, although LTE is turned on, the TER value doesn't increase or decrease. Figure 7.5-2 shows the computed normalized and time-averaged SAR and PD values for LTE and NR FR2, respectively, as well as their sum which is the TER value. We can see that the TER is always under the FCC compliance limit of 1, thus validating the TAS feature in this test case.

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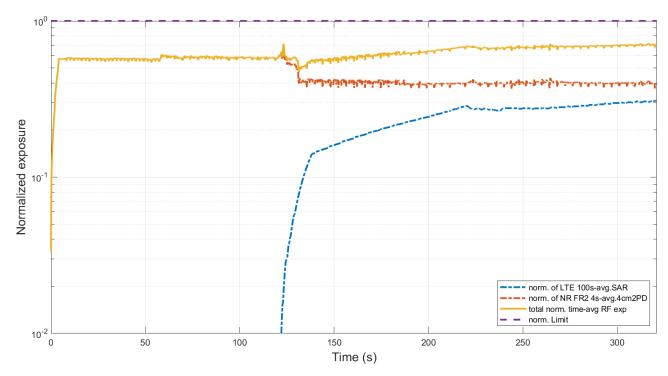


Figure 7.5-2 Total normalized time-average RF exposure in F\_TC04

FCC requirement for total RF exposure (normalized)	1.0	
Max total normalized time-averaged RF exposure (yellow curve)	0.714	
Validated		

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# 7.6 SAR vs. PD exposure switch

The results in this section were obtained following the procedure in Section 6.2 and corresponds to the test case F\_TC05 in Table 6.2.1.

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# 25 20 dBm 10 Measured LTE inst.power Measured LTE 100s-avg.power Measured NR FR2 inst.power Measured NR FR2 4s-avg.power Power limit for SAR\_design\_target of LTE Power limit for SAR\_design\_target of NR FR2 0

7.6.1 F\_TC05: mmWave\_Dominant\_Power\_Switching

Figure 7.6-1 Conducted power of LTE B2 and radiated EIRP of FR2 n260 in EN-DC max power case

Time (s)

Figure 7.6-1 shows the instantaneous and time-averaged conducted power for LTE and radiated power for NR FR2. In this test, we assumed that Plimit value for LTE is 21dBm when SAR\_design target is 0.72W/Kg, and the Plimit value of FR2 is 11.37dBm when PD\_design\_target is 4.42W/m2. When LTE is operated, FR2 power would be decreased to maintain TER value. After the average power of LTE is saturated as target power, the average power of FR2 is not decreased any more. After LTE is turned off, the average power of FR2 is increased to restore the original target power. As a result, whether LTE is turned on or not, the TER value dramatically doesn't increase or decrease.

Figure 7.6-2 shows the computed normalized and time-averaged SAR and PD values for LTE and NR FR2, respectively, as well as their sum which is the TER value. We can see that the TER is always under the FCC compliance limit of 1, thus validating the TAS feature in this test case.

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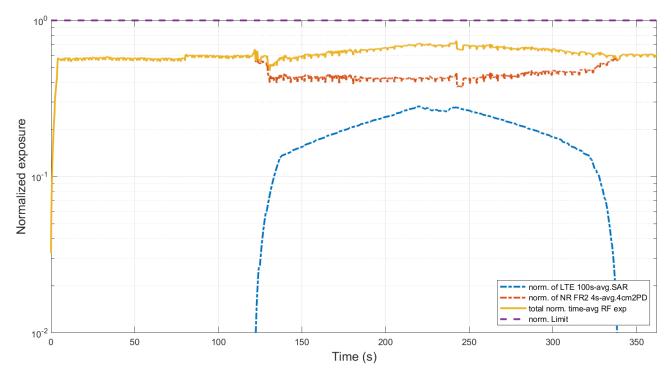


Figure 7.6-2 Total normalized time-average RF exposure in F\_TC05

FCC requirement for total RF exposure (normalized)	1.0	
Max total normalized time-averaged RF exposure (yellow curve)	0.741	
Validated		

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# 7.7 FR2 beam change

The results in this section were obtained following the procedure in Section 6.2 and corresponds to the test case F\_TC06 in Table 6.2.1.

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#### 7.7.1 F\_TC06: mmWave\_Module\_Beam\_Change

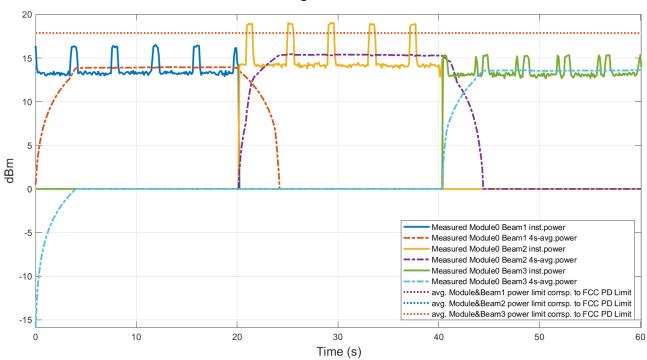


Figure 7.7-1 Measured radiated EIRP of FR2 n260 in mmWave Module beam change case F\_TC06

Figure 7.7-1 shows the instantaneous and time-averaged radiated power for NR FR2. We don't show the LTE transmit power, since it would be at the lowest level and doesn't meaningfully contribute to the TER. In this test, we assumed that the Plimit value of FR2 is 11.37dBm when PD\_design\_target is 4.42W/m2. Figure 7.7-2 shows the computed time-averaged PD for each selected module/beam setting as well as the total sum. When beam or module of FR2 would be changed, the sum of each beam/module is not higher than the target power limit. As a result, whether beam/module is changed or not, the TER value dramatically doesn't increase.

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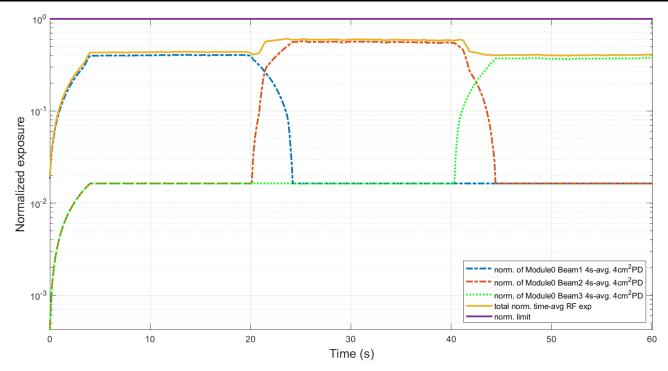


Figure 7.7-2 Total normalized time-average RF exposure

FCC requirement for total RF exposure (normalized)	1.0	
Max total normalized time-averaged RF exposure (yellow curve)	0.609	
Validated		

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## 7.8 Time-varying Tx power measurement results

The results in this section were obtained following the procedure in Section 6.2 and corresponds to the test case I\_TC07 in Table 6.2.1.

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## 7.8.1 F\_TC07: mmWave\_Max\_Tx\_Power

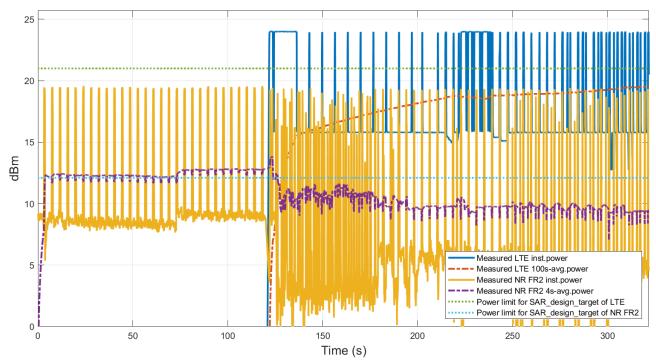


Figure 7.8-1 Conducted power of LTE B2 and radiated EIRP of FR2 n261 in EN-DC max power

Figure 7.8-1 shows the instantaneous and time-averaged conducted power for LTE and radiated power for NR FR2. In this test, we assumed that Plimit value for LTE is 21dBm when SAR\_design target is 0.72W/Kg, and the Plimit value of FR2 is 9.1dBm when PD\_design\_target is 4.42W/m2. When LTE is operated, FR2 power would be decreased to maintain TER value. After the average power of LTE is saturated as target power, the average power of FR2 is not decreased any more. As a result, although LTE is turned on, the TER value doesn't increase or decrease. Figure 7.8-2 shows the computed normalized and time-averaged SAR and PD values for LTE and NR FR2, respectively, as well as their sum which is the TER value. We can see that the TER is always under the FCC compliance limit of 1, thus validating the TAS feature in this test case.

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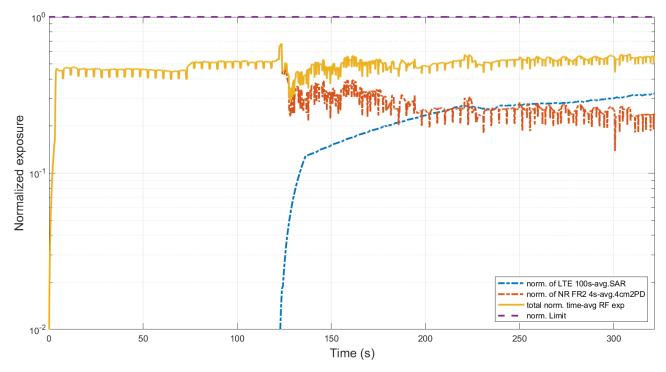


Figure 7.8-2 Total normalized time-average RF exposure in F\_TC07

FCC requirement for total RF exposure (normalized)	1.0	
Max total normalized time-averaged RF exposure (yellow curve)	0.678	
Validated		

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## 7.9 SAR vs. PD exposure switch

The results in this section were obtained following the procedure in Section 6.2 and corresponds to the test case F\_TC08 in Table 6.2.1.

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#### 7.9.1 F\_TC08: mmWave\_Dominant\_Power\_Switching

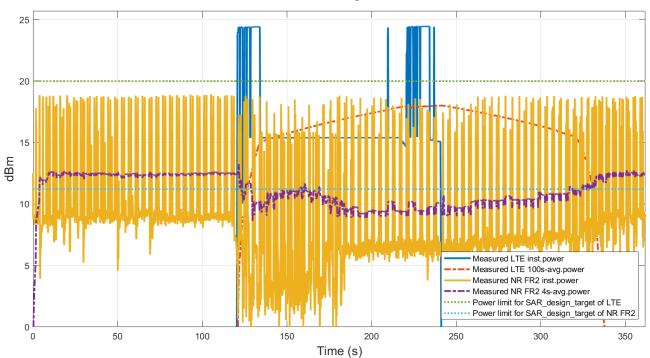


Figure 7.9-1 Conducted power of LTE B2 and radiated EIRP of FR2 n261 in EN-DC max power case

Figure 7.9-1 shows the instantaneous and time-averaged conducted power for LTE and radiated power for NR FR2. In this test, we assumed that Plimit value for LTE is 21dBm when SAR\_design target is 0.72W/Kg, and the Plimit value of FR2 is 9.1dBm when PD\_design\_target is 4.42W/m2. When LTE is operated, FR2 power would be decreased to maintain TER value. After the average power of LTE is saturated as target power, the average power of FR2 is not decreased any more. After LTE is turned off, the average power of FR2 is increased to restore the original target power. As a result, whether LTE is turned on or not, the TER value dramatically doesn't increase or decrease.

Figure 7.9-2 shows the computed normalized and time-averaged SAR and PD values for LTE and NR FR2, respectively, as well as their sum which is the TER value. We can see that the TER is always under the FCC compliance limit of 1, thus validating the TAS feature in this test case.

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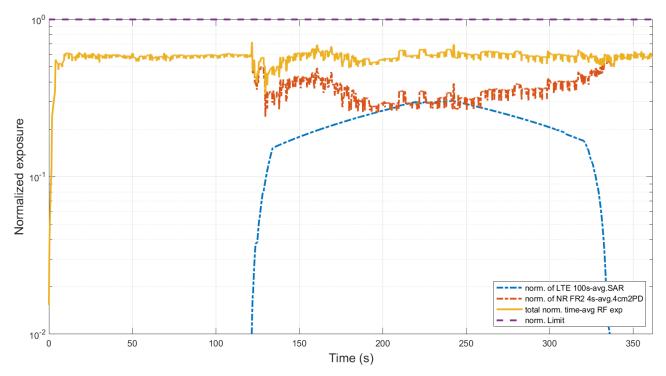


Figure 7.9-2 Total normalized time-average RF exposure in F\_TC08

FCC requirement for total RF exposure (normalized)	1.0	
Max total normalized time-averaged RF exposure (yellow curve)	0.582	
Validated		

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# 7.10 FR2 beam change

The results in this section were obtained following the procedure in Section 6.2 and corresponds to the test case F\_TC09 in Table 6.2.1.

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#### 7.10.1 F\_TC09: mmWave\_Module\_Beam\_Change

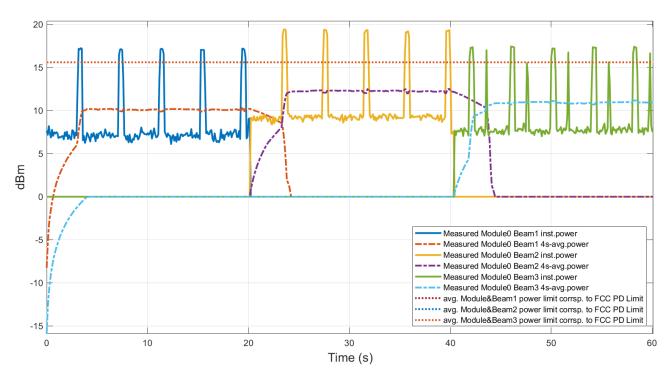


Figure 7.10-1 Measured radiated EIRP of FR2 n260 in mmWave Module beam change case F\_TC09

Figure 7.10-1 shows the instantaneous and time-averaged radiated power for NR FR2. We don't show the LTE transmit power, since it would be at the lowest level and doesn't meaningfully contribute to the TER. In this test, we assumed that the Plimit value of FR2 is 9.1dBm when PD\_design\_target is 4.42W/m2. Figure 7.10-2 shows the computed time-averaged PD for each selected module/beam setting as well as the total sum. When beam or module of FR2 would be changed, the sum of each beam/module is not higher than the target power limit. As a result, whether beam/module is changed or not, the TER value dramatically doesn't increase.

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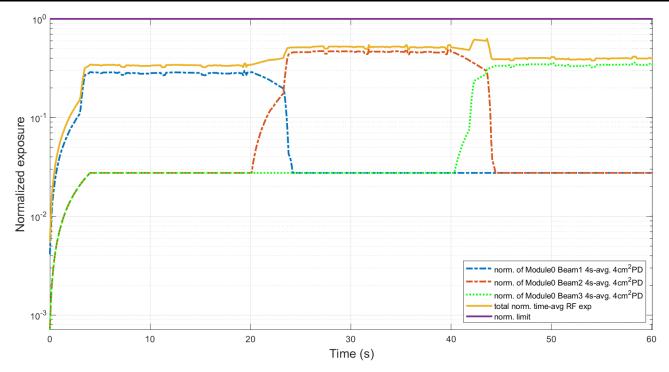


Figure 7.10-2 Total normalized time-average RF exposure

FCC requirement for total RF exposure (normalized)	1.0	
Max total normalized time-averaged RF exposure (yellow curve)	0.629	
Validated		

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# 8. Conclusions

Samsung S.LSI TAS feature employed in this product has been validated through the conducted power measurement for sub-6, radiated power measurement for FR2 as demonstrated in this report, the power limiting enforcement is effective and the total normalized time-averaged RF exposure does not exceed 1.0 for all the transmission scenarios. Therefore, the EUT complies with FCC RF exposure requirement.

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# 9. Annex

# 9.1 <u>Test sequence is generated based on below parameters of the DUT:</u>

- 1. Measured maximum power (Pmax)
- 2. Measured Tx power (Plimit) to satisfy SARCompliance
- 3. Setup time to make SARRemaining be full
- 4. Do test according to test sequence

# 9.2 Test Sequence A waveform:

Based on the parameters above, the Test Sequence A is generated with two power levels. One is maximum power
level and the other is lower power level. The lower power level is defined as 3dB lower value than maximum power
level. At first, maximum power level is applied for 120 seconds (SAR\_time\_window x 1.2). After then, lower power
level is used until this test is finished.

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# 9.3 Test Sequence B waveform:

• Based on the parameters above, the Test Type B is generated with pre-defined power levels, which is described in Table 9.4.1.

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Table 9.4.1 Table of test sequence B

Time duration (second) Power level (dB)			
15	Plimit - 5		
20	Plimit		
20	Plimit + 5		
10	Plimit – 6		
20	Pmax		
15	Plimit		
15	Plimit -7		
20	Pmax		
10	Plimit-5		
15	Plimit		
10	Plimit-6		
20	Plimit + 5		
10	Plimit – 4		
15	Plimit		
10	Plimit – 6		
20	Pmax		
15	Plimit-8		
15	Plimit		
20	Pmax		
10	Plimit – 9		
20	Plimit + 5		
20	Plimit		
15	Plimit – 5		

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# 10. Test Equipment List

Manufacturer	Name of Equipment	T /84 l . l	Serial Number	Calibration	
Manufacturer	Name of Equipment	Type/Model		Last Cal.	Due Date
Anritsu	Radio Communication Analyzer	MT8821C	6201381768	Mar. 11, 2021	Mar. 10, 2022
Anritsu	5G Wireless Test Platform	MT8000A	6262208374	Mar. 05, 2021	Mar. 04, 2022
Keysight	5G Wireless Test Platform	E7515B	MY59321826	Mar. 23, 2021	Mar. 22, 2022
Keysight	Power sensor	U2065XA	MY60000033	Jun. 22, 2021	Jun. 21, 2022
Keysight	Power sensor	U2065XA	MY60000034	Jun. 21, 2021	Jun. 20, 2022
Keysight	Power sensor	U8488A	MY59330012	Mar. 02, 2021	Mar. 01, 2022
Keysight	CATR measurement antenna	SAF-2434231535-328-S1-280-DP	16920-01	Not	te <sup>(1)</sup>
Testo	Hygro meter	608-H1	45196600	Nov. 10, 2020	Nov. 09, 2021
Anritsu	Signal Generator	MG3710A	6201502524	Nov. 11, 2020	Nov. 10, 2021
Anritsu	Power Meter	ML2496A	2119003	Jun. 09, 2021	Jun. 08, 2022
Anritsu	Power Sensor	MA2411B	1911333	Jun. 01, 2021	May. 31, 2022
Anritsu	Power Sensor	MA2411B	1911334	Jun. 01, 2021	May. 31, 2022
Warison	10-50 GHz Directional Coupler	WCOU-10-50S-10	WR889BMC481	Note (1)	
ATM	500M-18GHz Dual Directional Coupler	C122H-10	P610410z-02	Not	te <sup>(1)</sup>
Woken	Attenuator 1	WK0602-XX	N/A	Not	te <sup>(1)</sup>
Woken	Attenuator 2	PE7005-10	N/A	Not	te <sup>(1)</sup>
Woken	Attenuator 3	PE7005- 3	N/A	Not	te (1)

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Note <sup>(1)</sup>: Prior to conducted or EIRP power measurement, the path loss from the EUT to the power meter, which includes the RF cable, attenuator and directional coupler, was measured and determined.

# 11. References

The following documents contain reference in this technical document.

[1] 3GPP TR 37.815: Study on high power User Equipment (UE) (power class 2) for E-UTRA (Evolved Universal Terrestrial Radio Access) - NR Dual Connectivity (EN-DC) (1 LTE FDD band + 1 NR TDD band)

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